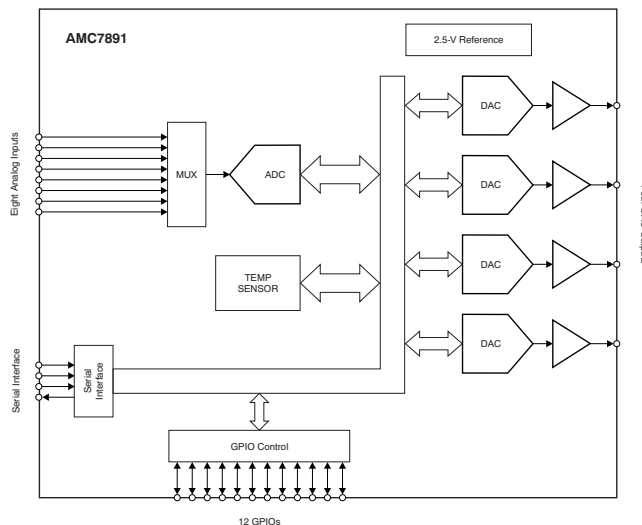


模拟监视器和控制电路 含有**10**位，多通道模数转换器**ADC**和**4**个数模转换器，温度传感器， 和**12**个通用输入输出接口(**GPIO**)

查询样品: [AMC7891](#)

特性

- **10**位，**500**每秒千次采样(**kSPS**) 逐次逼近寄存器型(**SAR**) **ADC**:
 - **8**个外部模拟输入
 - $V_{\text{基准}}(\text{REF})$, $2 \times V_{\text{REF}}$ 输入范围
- **4**个**10**位单片**DAC**:
 - **0**到**5V**输出范围
 - 最大**10mA**拉灌电流能力
 - 加电时，电压复位至**0V**
- 内部**2.5V**电压基准
- 内部温度传感器:
 - **-40°C**至**+125°C**运行温度范围
 - 准确度**±2.5°C**
- **12**个通用输入/输出(**I/O**)端口:
 - **1.8 V** 至 **5.5 V** 工作电压
- 低功率 串行外设接口(**SPI**)™- 兼容串口:
 - **4**线模式，**1.8V**至**5.5V**运行电压
 - **SCLK**时钟频率最高**30MHz**
- 温度范围: **-40°C** 至 **+105°C**
- 低功率: 完全运行条件下，电压**5V**时功耗为**32.5mW**
- 节省空间的封装方式: **36**引脚，**6mm x 6mm**方形扁平无引脚封装(**QFN**)



应用范围

- 蜂窝基站
- 射频(**RF**)通讯系统
- 光纤网络
- 通用监视器和控制

说明

AMC7891是一款高集成，低功率，完全模拟监控和控制系統，此系統采用极小型封装。

为了实现监控功能，AMC7891将8个未指定用途输入复用在一個10位SAR模数转化器(ADC)内并且还有一个准确片载温度传感器。控制信号由4个，独立的10位数模转换器(DAC)生成。额外的数字信号监视和控制通过12个可配置GPIO来完成。一个内部基准可被用于驱动ADC和DAC。

通过一个多用途，四线制串行接口来执行到此器件的通信，此接口与工业标准微处理器和微控制器兼容。此串行接口可运行最高30MHz的时钟频率下，这样可实现到关键系统数据的快速访问。

此器件额定运行温度范围为-40°C至105°C并采用极小型，36引脚，6mm x 6mm QFN封装。



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English Data Sheet: [SBAS518](#)

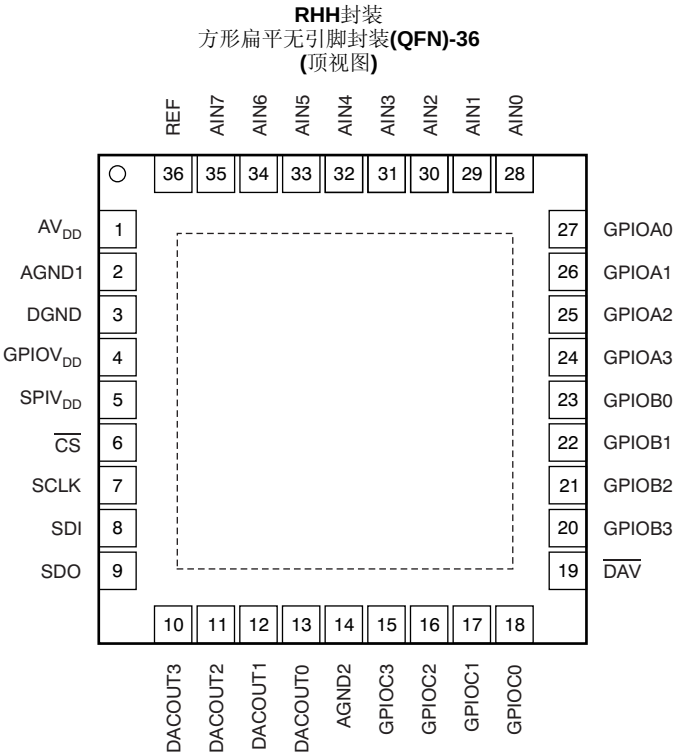
AMC7891的低功率，小尺寸和高集成度使得它成为低成本，偏压控制电路的理想选择，此电路用于最新的RF晶体管，例如RF通信系统中的功率放大器(PA)和低噪声放大器(LNA)。 AMC7891

对于那些要求一个不同的通道数，额外的特性，或者转换器解决方案的应用，德州仪器提供一个模拟监视器和控制(AMC)产品的完整系列产品。 请见网站<http://www.ti.com/amc>。



这些装置包含有限的内置 ESD 保护。

存储或装卸时，应将导线一起截短或将装置放置于导电泡棉中，以防止 MOS 门极遭受静电损伤。

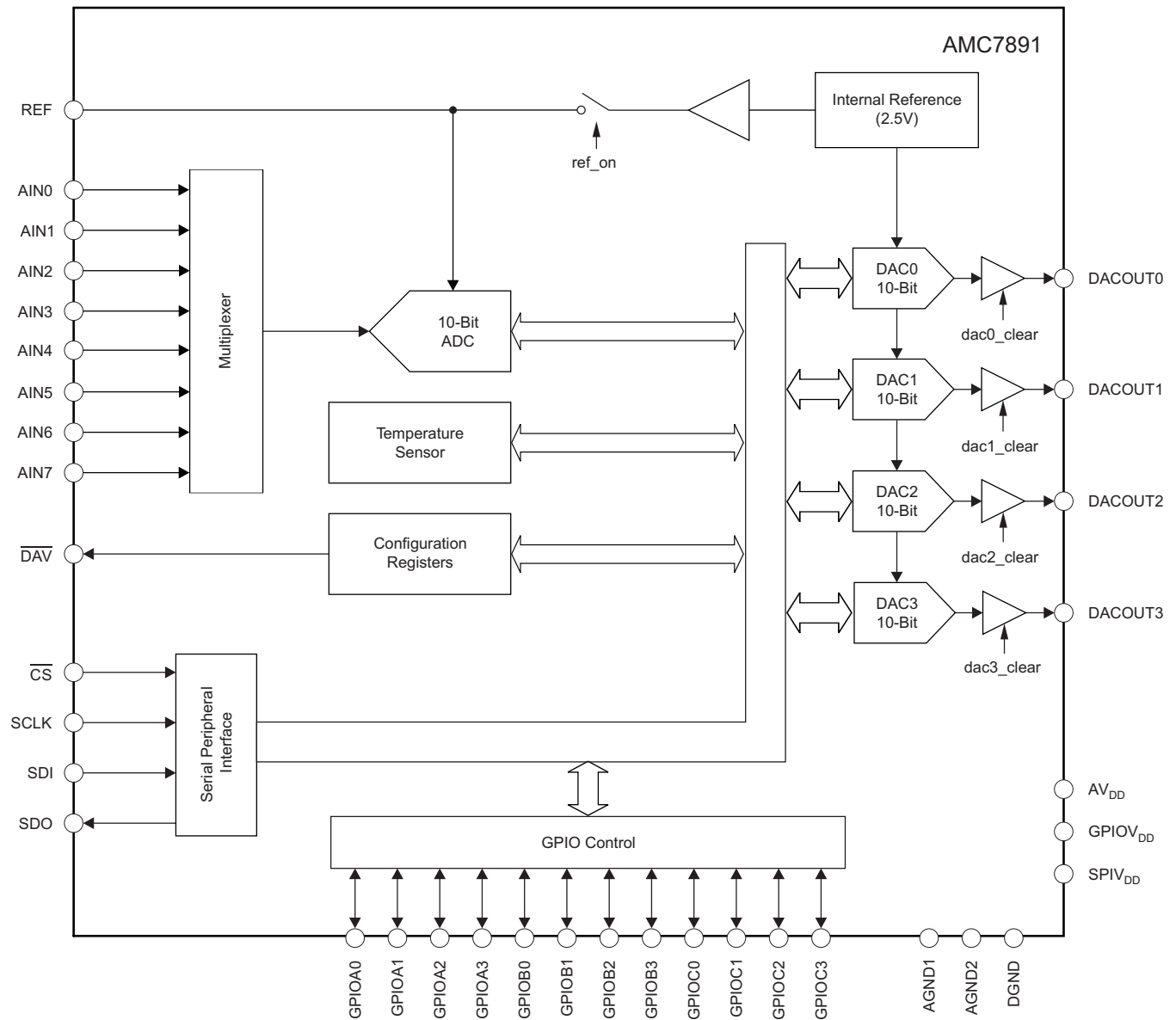


AMC7891引脚功能

引脚		I/O	说明
编号	名称		
1	AV _{DD}	I	模拟电源电压。(4.75 V 至 5.5 V)
2	AGND1	I	模拟接地。此器件上用于所用模拟电路的接地基准点，AGND。连接AGND1和AGND2到同一个电位上，AGND。
3	数字接地(DGND)	I	数字接地。此器件上用于所有数字电路的接地基准点。在理想条件下，AGND和DGND应该在同一电位上并且它们之间的电位差异不能大于0.3V。
4	GPIOV _{DD}	I	GPIO电源电压。(1.8V至5.5V) 设定GPIO运行电压和阈值电平。
5	SPIV _{DD}	I	串行接口电源电压。(1.8V至5.5V) 设定串行接口运行电压和阈值电平。
6	$\overline{CS}$	I	低电平有效串行数据使能。施密特(Schmitt)-触发逻辑电路。 此输入是串行数据的帧同步信号。当此信号变为低电平时，它打开输入移位寄存器并且在随后的下降时钟沿上进行数据采样。DAC输出和寄存器设置在第24个时钟之后更新。如果 $\overline{CS}$ 在第23个时钟边沿前变为高电平，则忽略此命令。
7	SCLK	I	串口时钟。施密特(Schmitt)-触发逻辑输入。 最大SCLK频率为30MHz。
8	SDI	I	串口数据输入。施密特(Schmitt)-触发逻辑输入。 数据在每个SCLK下降沿上进入输入移位寄存器。

AMC7891引脚功能 (接下页)

引脚		I/O	说明
编号	名称		
9	SDO	O	串口数据输出。当 $\overline{CS}$ 是高电平时, 此SDO引脚为高阻抗。在SCLK的每个上升沿上, 数据从输入移位寄存器中时钟输出。
10	DACOUT3	O	DAC3缓冲输出。(0 V 至 AV_{DD}) 拉/灌电流可高达10mA。
11	DACOUT2	O	DAC2缓冲输出。(0 V 至 AV_{DD}) 拉/灌电流可高达10mA。
12	DACOUT1	O	DAC1缓冲输出。(0 V 至 AV_{DD}) 拉/灌电流可高达10mA。
13	DACOUT0	O	DAC0缓冲输出。{0 V 至 AV_{DD} } 拉/灌电流可高达10mA。
14	AGND2	I	模拟接地。此器件上所有模拟电路的接地基准点, AGND。将AGND1和AGND2连接至同一电位, AGND。
15	GPIOC3	I/O	通用数字 I/O C3。最大电压由GPIOV _{DD} 设定
16	GPIOC2	I/O	通用数字 I/O C2。最大电压由GPIOV _{DD} 设定
17	GPIOC1	I/O	通用数字 I/O C1。最大电压由GPIOV _{DD} 设定
18	GPIOC0	I/O	通用数字 I/O C0。最大电压由GPIOV _{DD} 设定
19	$\overline{DAV}$	O	ADC数据获得性指示器。开漏电路, 低电平有效输出。 在直接模式下, 当一个ADC转换周期完成时, $\overline{DAV}$ 变成低电平。在自动模式下, 当此转换周期完成时, 一个1 μ s脉冲出现在这个引脚上(更多细节请参见ADC运行) 当无效时, $\overline{DAV}$ 保持高电平。如果使用的话, 需要一个到GPIOV _{DD} 的外部10k Ω 上拉电阻器。如果没有使用的话, 此引脚可连接至DGND。
20	GPIOB3	I/O	通用数字 I/O B3。最大电压由GPIOV _{DD} 设定
21	GPIOB2	I/O	通用数字 I/O B2。最大电压由GPIOV _{DD} 设定
22	GPIOB1	I/O	通用数字 I/O B1。最大电压由GPIOV _{DD} 设定
23	GPIOB0	I/O	通用数字 I/O B1。最大电压由GPIOV _{DD} 设定
24	GPIOA3	I/O	通用数字 I/O A3。最大电压由GPIOV _{DD} 设定
25	GPIOA2	I/O	通用数字 I/O A2。最大电压由GPIOV _{DD} 设定
26	GPIOA1	I/O	通用数字 I/O A1。最大电压由GPIOV _{DD} 设定
27	GPIOA0	I/O	通用数字 I/O A1。最大电压由GPIOV _{DD} 设定
28	AIN0	I	未指定用途的模拟输入0。(0 V 至 5 V)
29	AIN1	I	未指定用途的模拟输入1。(0 V 至 5 V)
30	AIN2	I	未指定用途的模拟输入2。(0 V 至 5 V)
31	AIN3	I	未指定用途的模拟输入3。(0 V 至 5 V)
32	AIN4	I	未指定用途的模拟输入4。(0 V 至 5 V)
33	AIN5	I	未指定用途的模拟输入5。(0 V 至 5 V)
34	AIN6	I	未指定用途的模拟输入6。(0 V 至 5 V)
35	AIN7	I	未指定用途的模拟输入7。(0 V 至 5 V)
36	REF	I/O	当寄存器 <i>AMC_power_ref_on</i> = '0' (默认值) 内的内部基准缓冲器被置为失效时被用作外部ADC基准输入。为了过滤噪音, 建议在外部基准输出和AGND之间放置一个去耦电容器。 当寄存器 <i>AMC_power_ref_on</i> = '1' 内的内部基准缓冲器被开启时被用作内部基准输出。当被用作基准输出时, 一个4.7 μ F去耦电容器需要连接至AGND。为了驱动一个外部负载, 需要一个具有高阻抗输入的外部缓冲器放大器。
–	散热垫	–	散热垫位于封装的底部。使用多重方式连接至电路板接地层。

FUNCTIONAL BLOCK DIAGRAM

ORDERING INFORMATION⁽¹⁾

T _A	ORDER CODE	PACKAGE DRAWING/TYPE ⁽²⁾⁽³⁾	TRANSPORT MEDIA	QUANTITY
–40°C to 105°C	AMC7891SRHHT	RHH / 36-QFN Quad Flatpack No-Lead	Tape and Reel	250
	AMC7891SRHHR			2000

- (1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the device product folder at www.ti.com.
(2) Thermal Pad Size: 4.39 mm x 4.39 mm
(3) MSL Peak Temperature: Level-3-260C-168 HR

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Over operating free-air temperature range, unless otherwise noted.

		VALUE		UNIT
		MIN	MAX	
Supply voltage range	AV _{DD} to AGND ⁽²⁾	–0.3	6	V
	GPIOV _{DD} to DGND	–0.3	6	V
	SPIV _{DD} to DGND	–0.3	6	V
	AGND to DGND	–0.3	0.3	V
Pin voltage range	AIN[0:7], DACOUT[0:3], REF to AGND	–0.3	AV _{DD} + 0.3	V
	$\overline{CS}$, SCLK, SDI to DGND	–0.3	6	V
	SDO to DGND	–0.3	SPIV _{DD} + 0.3	V
	GPIOA[0:3], GPIOB[0:3], GPIOC[0:3] to DGND	–0.3	GPIOV _{DD} + 0.3	V
	$\overline{DAV}$ to DGND	–0.3	6	V
Operating free-air temperature range, T _A : AMC7891 ⁽³⁾⁽⁴⁾		–40	105	°C
Storage temperature range		–40	150	°C
ESD ratings:	Human body model (HBM)		2.5	kV
	Charged device model (CDM)		1.0	kV

- (1) Stresses above those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. Exposure to absolute maximum conditions for extended periods may affect device reliability.
(2) AGND1 and AGND2 must be tied together as AGND.
(3) Air flow or heat sinking reduces θ_{JA} and may be required for sustained operation at 105°C and maximum operating conditions.
(4) Soldering the device thermal pad to the board ground plane is strongly recommended.

THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾		AMC7891	UNITS
		RHH PACKAGE	
		36 PINS	
θ_{JA}	Junction-to-ambient thermal resistance	30.6	°C/W
θ_{JCTop}	Junction-to-case (top) thermal resistance	16.0	
θ_{JB}	Junction-to-board thermal resistance	5.3	
ψ_{JT}	Junction-to-top characterization parameter	0.2	
ψ_{JB}	Junction-to-board characterization parameter	5.3	
θ_{JCbott}	Junction-to-case (bottom) thermal resistance	0.8	

- (1) 有关传统和新的热度的更多信息，请参阅 IC 封装热量应用报告 [SPRA953](#)。

ELECTRICAL CHARACTERISTICS (DAC SPECIFICATIONS)

AV_{DD} = 4.75 to 5.5 V, $GPIOV_{DD}$ = 1.8 to 5.5 V, $SPIV_{DD}$ = 1.8 to 5.5 V, AGND = DGND = 0 V, External ADC reference = AV_{DD} , T_A = -40°C to 105°C (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
STATIC ACCURACY					
Resolution		10			Bits
INL Relative accuracy			±0.05	±1	LSB
DNL Differential nonlinearity	Specified monotonic		±0.1	±1	LSB
Offset error	Code 0x008		±0.5	±5	mV
Gain error			±0.025	±0.2	%FSR
Offset temperature coefficient			±1		ppm/°C
Gain temperature coefficient			±1		ppm/°C
DAC OUTPUT ⁽¹⁾					
Full scale output voltage range		0		AV_{DD}	V
Output voltage settling time	Transition: Code 0x008 to 0x3F8 to within 1/2 LSB, C_L = 2 nF, R_L = ∞		5		μs
Slew rate			2		V/μs
Short circuit current	Full-scale current shorted to ground or pulled to AV_{DD}		±30		mA
Load current	Source and/or sink within 300 mV of supply		±10		mA
Capacitive load stability	R_L = ∞	10			nF
DC output impedance			1		Ω
Power-on overshoot	AV_{DD} 0 to 5 V, 2 ms ramp		10		mV
Glitch energy	Transition: Code 0x1FF to 0x200; 0x200 to 0x1FF		0.15		nV-s
Output noise	T_A = 25°C, 1 kHz		260		nV/√Hz
	Integrated noise from 0.1 Hz to 10 Hz		20		μV _{pp}

(1) Specified by design and characterization. Not tested during production.

ELECTRICAL CHARACTERISTICS – (ADC SPECIFICATIONS)

$AV_{DD} = 4.75$ to 5.5 V, $GPIOV_{DD} = 1.8$ to 5.5 V, $SPIV_{DD} = 1.8$ to 5.5 V, $AGND = DGND = 0$ V, External ADC reference = AV_{DD} , $T_A = -40^{\circ}\text{C}$ to 105°C (unless otherwise noted)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC ACCURACY					
Resolution		10			Bits
INL Integral nonlinearity		± 0.1		± 1	LSB
DNL Differential nonlinearity	Specified monotonic	± 0.1		± 1	LSB
Offset error		± 0.5		± 2	LSB
Offset error match		± 0.4			LSB
Gain error		± 0.5		± 2	LSB
Gain error match		± 0.4			LSB
CONVERSION TIME					
ADC conversion rate		500			kSPS
Autocycle update rate	All 8 ADC input channels enabled	16			μs
Throughput rate	$SCLK \geq 12$ MHz, single analog channel			500	kSPS
Conversion delay	Delay from trigger to conversion start	2		4	μs
ANALOG INPUT					
Absolute input voltage range	Independent of gain setting	$AGND - 0.2$		$AV_{DD} + 0.2$	V
Full scale input voltage range	Gain = 1, $adc_{n_gain} = '0'$	0		V_{REF}	V
	Gain = 2, $adc_{n_gain} = '1'$	0		$2 \times V_{REF}$	V
Input capacitance ⁽¹⁾		40			pF
DC input leakage current	Measured with ADC in Hold mode			± 1	μA
AC PERFORMANCE					
SFDR Spurious Free Dynamic Range	$f_{IN} = 1$ kHz, -1 dBFS sine wave		76		dBc
SNR Signal to Noise Ratio	$f_{IN} = 1$ kHz, -1 dBFS sine wave		61		dBc
SINAD Signal to Noise+Distortion Ratio	$f_{IN} = 1$ kHz, -1 dBFS sine wave		60.5		dBc
THD Total Harmonic Distortion	$f_{IN} = 1$ kHz, -1 dBFS sine wave, Measured up to the fifth harmonic		75		dBc
INTERNAL ADC REFERENCE ⁽²⁾					
V_{REF} Reference output voltage	Internal ADC reference buffered output at REF pin		2.5		V
Reference buffer power	$AV_{DD} = 5$ V		360		μA
Reference temperature coefficient			10		ppm/ $^{\circ}\text{C}$
EXTERNAL ADC REFERENCE					
V_{REF} Reference input voltage	External ADC reference input to REF pin	0.3		AV_{DD}	V
Input resistance ⁽¹⁾	$V_{REF} = 5$ V, $A_{IN} = 5$ V		20		k Ω
TEMPERATURE SENSOR					
Operating range		-40		125	$^{\circ}\text{C}$
Accuracy	$T_A = -40^{\circ}\text{C}$ to 125°C , $AV_{DD} = 5$ V		± 1	± 2.5	$^{\circ}\text{C}$
Resolution	LSB size		0.125		$^{\circ}\text{C}$
Conversion time			15		ms

(1) Specified by design. Not tested during production.

(2) Use an external buffer amplifier with high impedance input to drive any external load.

ELECTRICAL CHARACTERISTICS – GENERAL SPECIFICATIONS

$AV_{DD} = 4.75$ to 5.5 V, $GPIOV_{DD} = 1.8$ to 5.5 V, $SPIV_{DD} = 1.8$ to 5.5 V, $AGND = DGND = 0$ V, External ADC reference = AV_{DD} , $T_A = -40^{\circ}\text{C}$ to 105°C (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
GENERAL PURPOSE I/O							
V _{IH}	High-level input voltage	GPIOV _{DD} = 1.8 V	0.7×GPIOV _{DD}			V	
		GPIOV _{DD} = 3.3 to 5.5 V	2.1			V	
V _{IL}	Low-level input voltage	GPIOV _{DD} = 1.8 V	0.3			V	
		GPIOV _{DD} = 3.3 to 5.5 V	0.8			V	
V _{OH}	High-level output voltage	I _{load} = 1.6 mA, GPIOV _{DD} = 1.8V, All GPIOs loaded and set to '1'	GPIOV _{DD} - 0.25			V	
		I _{load} = 1.6 mA, GPIOV _{DD} = 3.3 to 5.5V, All GPIOs loaded and set to '1'	GPIOV _{DD} - 0.2			V	
V _{OL}	Low-level output voltage	I _{load} = -1.6 mA, All GPIOs loaded	0.4			V	
Input capacitance ⁽¹⁾			1			pF	
High impedance output capacitance ⁽¹⁾			1			pF	
LOGIC INPUTS: $\overline{\text{CS}}$, SDI, SCLK							
V _{IH}	High-level input voltage	SPIV _{DD} = 1.8 V	0.7×SPIV _{DD}			V	
		SPIV _{DD} = 3.3 to 5.5 V	2.1			V	
V _{IL}	Low-level input voltage	SPIV _{DD} = 1.8 V	0.3			V	
		SPIV _{DD} = 3.3 to 5.5 V	0.7			V	
Input current			±1			μA	
Input capacitance ⁽¹⁾			1			pF	
High impedance output capacitance ⁽¹⁾			1			pF	
LOGIC OUTPUT: SDO							
V _{OH}	High-level output voltage	I _{load} = 1.6 mA	SPIV _{DD} - 0.2			V	
V _{OL}	Low-level output voltage	I _{load} = -1.6 mA	0.4			V	
LOGIC OUTPUT: $\overline{\text{DAV}}$							
V _{OL}	Low-level output voltage	I _{load} = -2 mA	0.4			V	
POWER REQUIREMENTS							
AV _{DD}			4.75	5	5.5	V	
GPIOV _{DD}			1.8		5.5	V	
SPIV _{DD}			1.8		5.5	V	
I _{DD}	Total supply current, AV _{DD} + GPIOV _{DD} + SPIV _{DD}	Operating mode ⁽²⁾	6.5			10	mA
		Power down mode	1.25			2	mA
Power consumption		Operating mode ⁽²⁾	32.5			55	mW
		Power down mode	6.25			11	mW
OPERATING RANGE							
Specified temperature range			−40	25	105	°C	

(1) Specified by design. Not tested in production.

(2) $AV_{DD} = GPIOV_{DD} = SPIV_{DD} = 5$ V. No DAC load, all DACs at 0x200 code and ADC at the fastest auto conversion rate.

TIMING SPECIFICATIONS⁽¹⁾⁽²⁾

$AV_{DD} = 4.75$ to 5.5 V, $GPIOV_{DD} = 1.8$ to 5.5 V, $SPIV_{DD} = 1.8$ to 5.5 V, $AGND = DGND = 0$ V, External ADC reference = AV_{DD} , $T_A = -40^{\circ}\text{C}$ to 105°C (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{SCLK} SCLK frequency	$SPIV_{DD} = 5.5$ V			30	MHz
	$SPIV_{DD} = 2.7$ V			15	MHz
	$SPIV_{DD} = 1.8$ V			10	MHz
t_R Input rise time	10% to 90% of $SPIV_{DD}$			2	ns
t_F Input fall time	10% to 90% of $SPIV_{DD}$			2	ns
t_1 SCLK cycle time	$SPIV_{DD} = 5.5$ V	33			ns
	$SPIV_{DD} = 2.7$ V	66			ns
	$SPIV_{DD} = 1.8$ V	100			ns
t_2 SCLK high time	$SPIV_{DD} = 5.5$ V	13			ns
	$SPIV_{DD} = 2.7$ V	30			ns
	$SPIV_{DD} = 1.8$ V	50			ns
t_3 SCLK low time	$SPIV_{DD} = 5.5$ V	13			ns
	$SPIV_{DD} = 2.7$ V	26			ns
	$SPIV_{DD} = 1.8$ V	40			ns
t_4 Frame start time	$\overline{\text{CS}}$ falling edge to SCLK rising edge	5			ns
t_5 SDI setup time	SDI valid to falling edge of SCLK	4			ns
t_6 SDI hold time	SDI valid after falling edge of SCLK	12			ns
t_7 Frame stop time	SCLK falling edge to $\overline{\text{CS}}$ rising edge	15			ns
t_8 $\overline{\text{CS}}$ high time		50			ns
t_9 SDO delay	$SPIV_{DD} = 5.5$ V, $C_L = 10$ pF, $1 \text{ ns} \leq t_{R,F}(\text{SDO}) \leq 4 \text{ ns}$	5		16	ns
	$SPIV_{DD} = 2.7$ V, $C_L = 10$ pF, $1 \text{ ns} \leq t_{R,F}(\text{SDO}) \leq 5 \text{ ns}$	6		22	ns
	$SPIV_{DD} = 1.8$ V, $C_L = 10$ pF, $2 \text{ ns} \leq t_{R,F}(\text{SDO}) \leq 8 \text{ ns}$	8		39	ns
t_{10} Wait time	$\overline{\text{CS}}$ rising edge to next SCLK rising edge	5			ns

(1) Specified by design. Not tested during production.

(2) Digital inputs and outputs timed from a voltage level of $SPIV_{DD}/2$.

TIMING INFORMATION

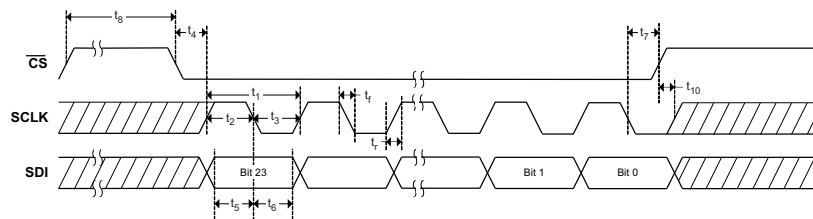


Figure 1. Serial Interface Write Timing Diagram

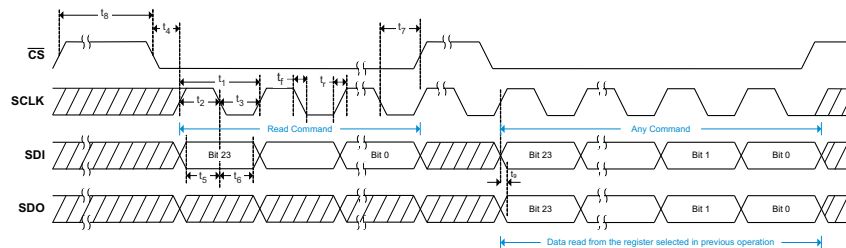


Figure 2. Serial Interface Read Timing Diagram

TYPICAL CHARACTERISTICS: DAC

$AV_{DD} = 5\text{ V}$, $GPIOV_{DD} = 5\text{ V}$, $SPIV_{DD} = 5\text{ V}$, $AGND = DGND = 0\text{ V}$, External ADC reference = AV_{DD}
(unless otherwise noted)

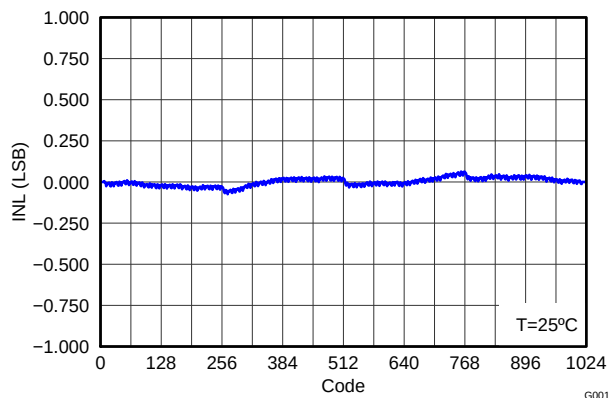


Figure 3. DAC INTEGRAL NON-LINEARITY

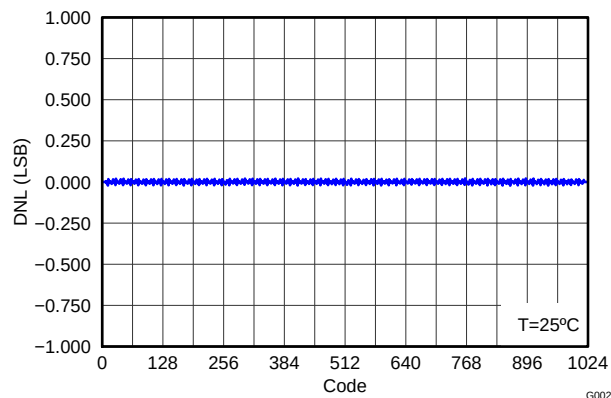


Figure 4. DAC DIFFERENTIAL NON-LINEARITY

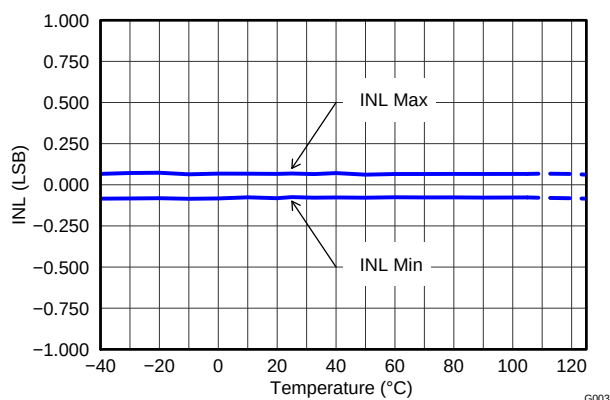


Figure 5. DAC INL vs. TEMPERATURE

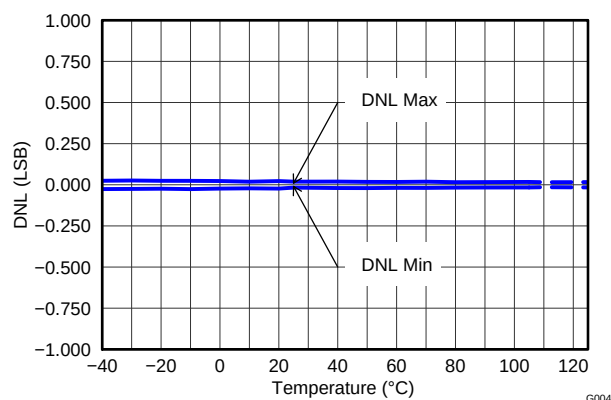


Figure 6. DAC DNL vs. TEMPERATURE

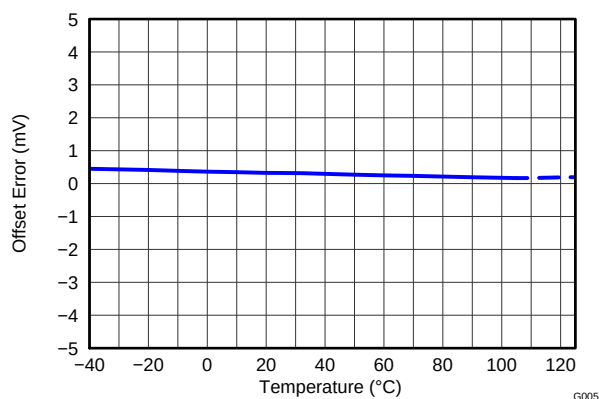


Figure 7. DAC OFFSET ERROR vs. TEMPERATURE

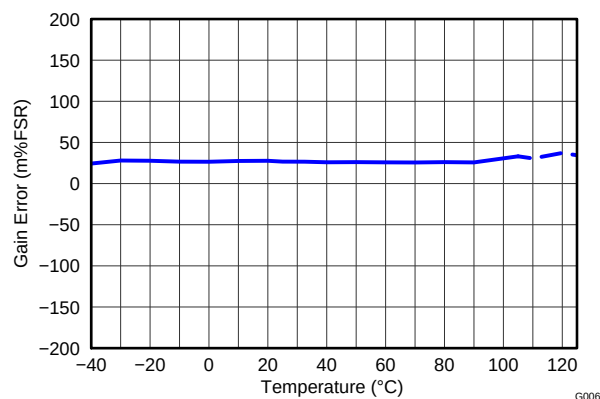


Figure 8. DAC GAIN ERROR vs. TEMPERATURE

TYPICAL CHARACTERISTICS: DAC (continued)

$AV_{DD} = 5\text{ V}$, $GPIOV_{DD} = 5\text{ V}$, $SPIV_{DD} = 5\text{ V}$, $AGND = DGND = 0\text{ V}$, External ADC reference = AV_{DD}

(unless otherwise noted)

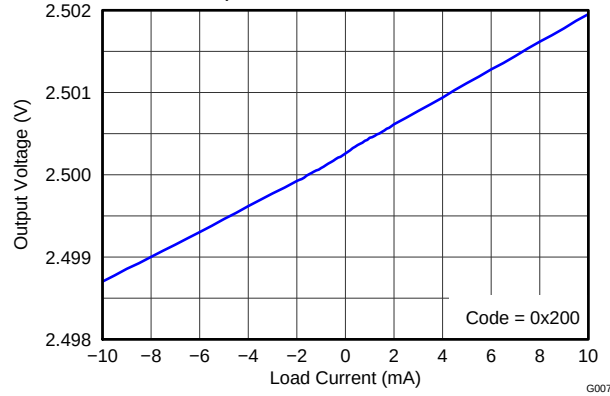


Figure 9. DAC OUTPUT VOLTAGE vs. LOAD CURRENT

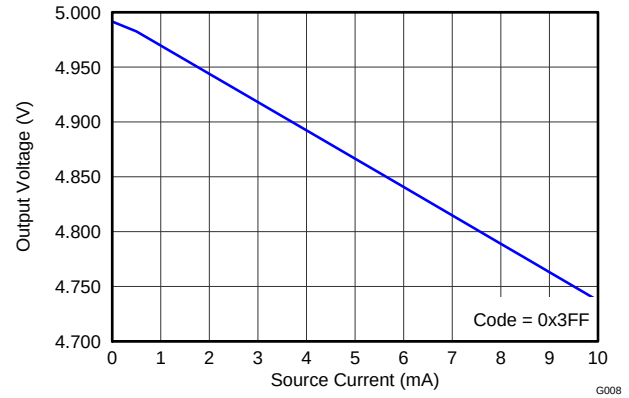


Figure 10. DAC SOURCE CURRENT

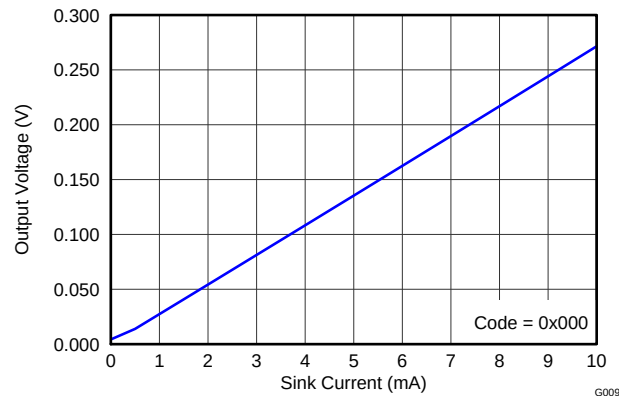


Figure 11. DAC SINK CURRENT

TYPICAL CHARACTERISTICS: ADC

$AV_{DD} = 5\text{ V}$, $GPIOV_{DD} = 5\text{ V}$, $SPIV_{DD} = 5\text{ V}$, $AGND = DGND = 0\text{ V}$, External ADC reference = AV_{DD}
(unless otherwise noted)

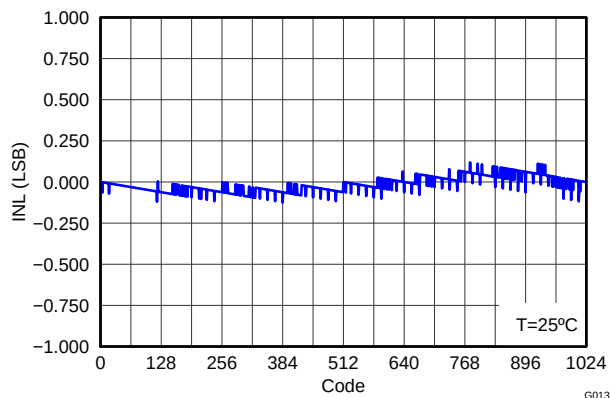


Figure 12. ADC INTEGRAL NON-LINEARITY

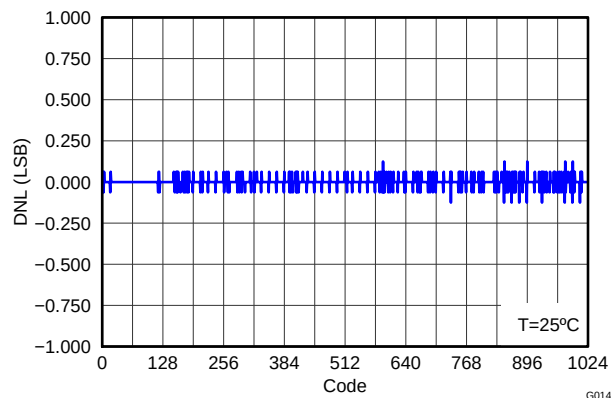


Figure 13. ADC DIFFERENTIAL NON-LINEARITY

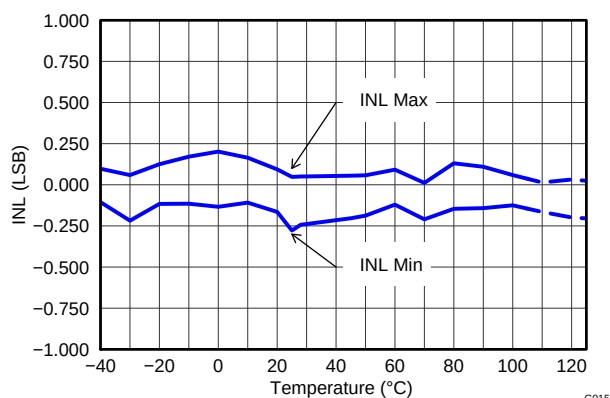


Figure 14. ADC INL vs. TEMPERATURE

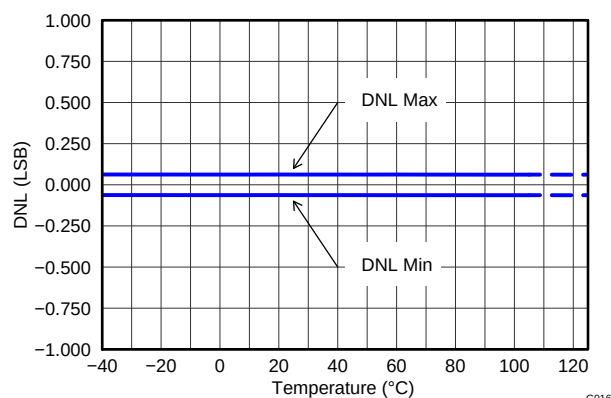


Figure 15. ADC DNL vs. TEMPERATURE

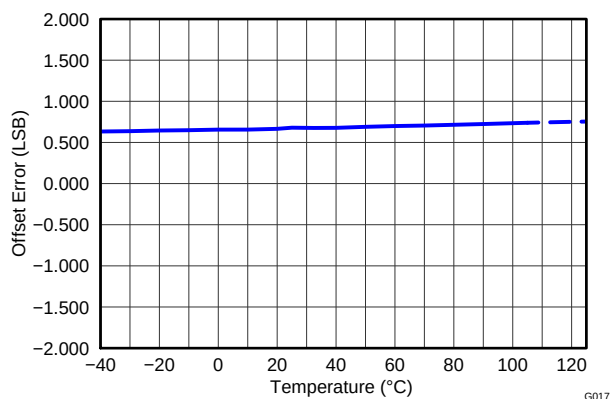


Figure 16. ADC OFFSET ERROR vs. TEMPERATURE

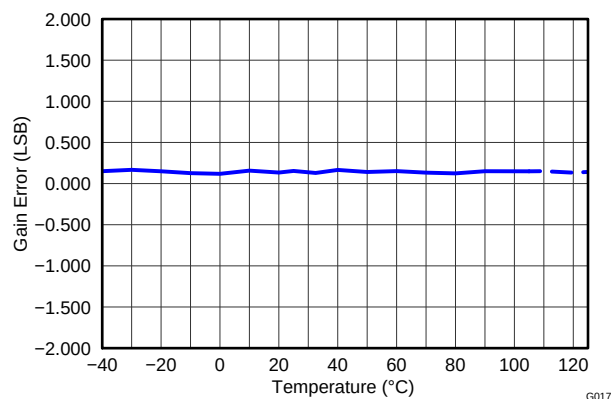


Figure 17. ADC GAIN ERROR vs. TEMPERATURE

TYPICAL CHARACTERISTICS: ADC (continued)

$AV_{DD} = 5\text{ V}$, $GPIOV_{DD} = 5\text{ V}$, $SPIV_{DD} = 5\text{ V}$, $AGND = DGND = 0\text{ V}$, External ADC reference = AV_{DD}

(unless otherwise noted)

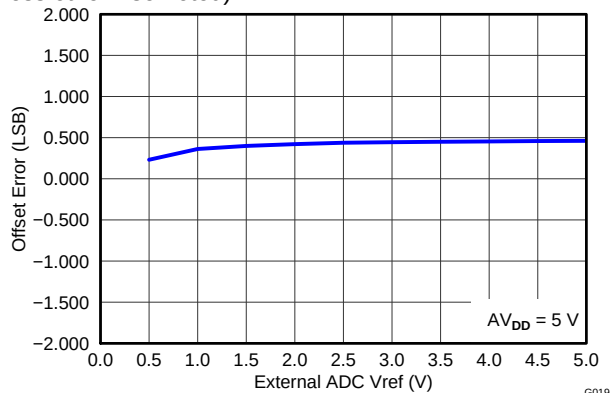


Figure 18. ADC OFFSET ERROR vs. REFERENCE VOLTAGE

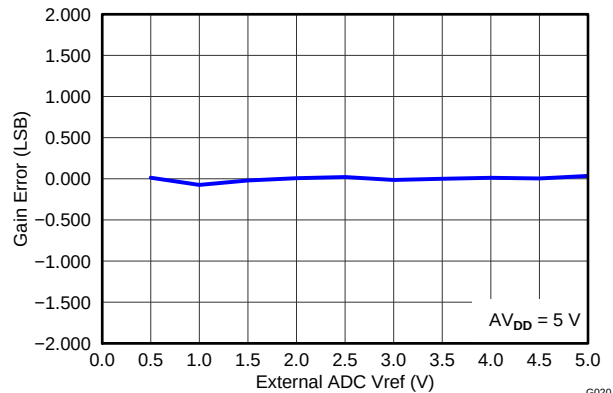


Figure 19. ADC GAIN ERROR vs. REFERENCE VOLTAGE

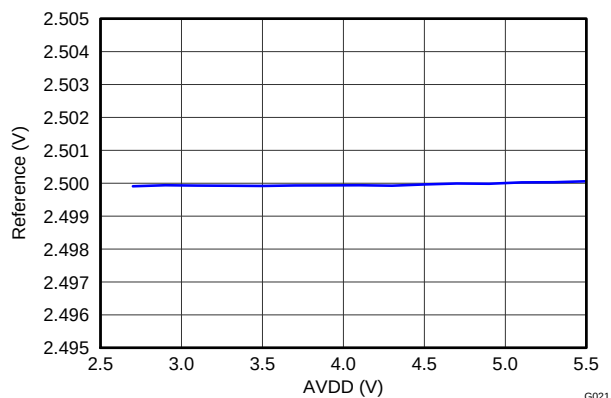


Figure 20. ADC INTERNAL REFERENCE vs. AV_{DD}

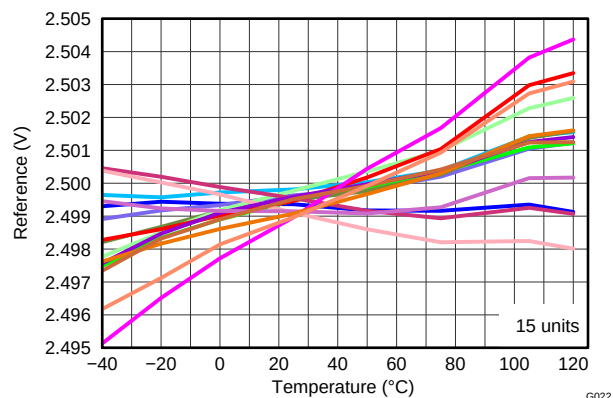


Figure 21. ADC INTERNAL REFERENCE vs. TEMPERATURE

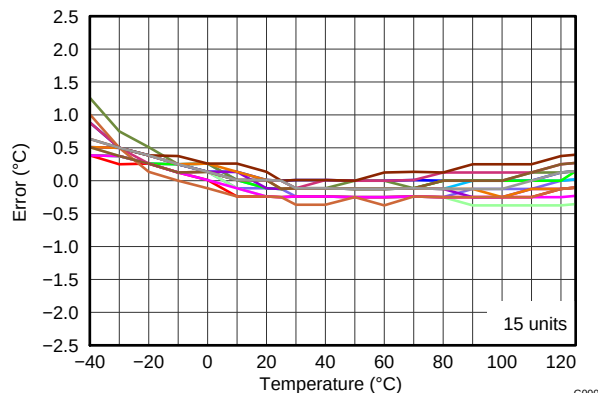


Figure 22. TEMPERATURE SENSOR ERROR vs TEMPERATURE

THEORY OF OPERATION

SERIAL INTERFACE

The AMC7891 is controlled through a flexible four-wire serial interface compatible with industry standard microprocessors and microcontrollers. The interface provides read/write access to all registers of the AMC7891 with clock rates up to 30 MHz.

The interface is compatible with most synchronous transfer formats and is configured as a 4 pin interface. SCLK is the serial interface input clock and $\overline{CS}$ is serial interface enable. Data is input into SDI and latched into the 24-bit wide SPI shift register on SCLK falling edges, while $\overline{CS}$ is low. Data is clocked out of SDO on SCLK rising edges, while $\overline{CS}$ is low. The contents of the SPI shift register are loaded into the device internal register on a $\overline{CS}$ rising edge after some delay. When $\overline{CS}$ is high, both SCLK and SDI inputs are blocked out and the SDO output is in high-impedance state.

The serial interface works with both a continuous and a non-continuous serial clock. A continuous SCLK source can only be used if $\overline{CS}$ is held low for the correct number of clock cycles. In gated clock mode, a burst clock containing the exact number of clock cycles must be used and $\overline{CS}$ must be taken high after the final clock to latch the data.

Each SPI command is input to SDI and framed by signal $\overline{CS}$ (Serial Data Enable) asserted low. The frame's first byte into SDI is the instruction cycle which identifies the request as a read or write as well as the 7-bit address to be accessed. The following two bytes in the frame form the data cycle.

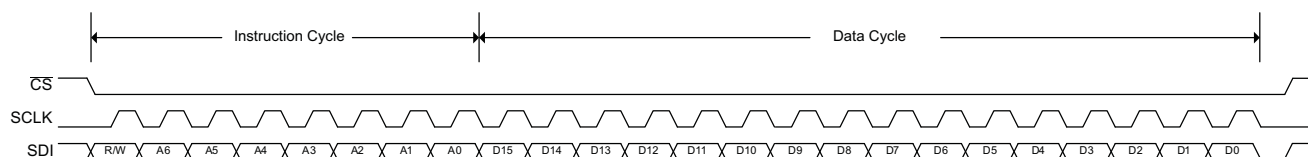


Figure 23. Serial Interface Command

- Bit 23** **R/W.** Identifies the communication as a read or write command to the addressed register. Bit = '0' sets the write operation. Bit = '1' sets the read operation.
- Bits[22:16]** **A[6:0].** Register address; specifies the register to be accessed during the read or write operation.
- Bits[15:0]** **D[15:0].** Data cycle bits.
If a write command, the data cycle bits are the values to be written to the register with address A[6:0].
If a read command, the data cycle bits are *don't care* values.

A read command causes an output on the SDO pin during the next SPI command cycle. The SDO read value frame is formed by the previous communication instruction cycle and the data read from the specified register.

Table 1. Serial Data Format

SPI FRAME	PIN	INSTRUCTION CYCLE		DATA CYCLE
		Bit 23	Bits [22:16]	Bits [15:0]
Write Command Frame	SDI	0 (R/W)	A[6:0]	Data In[15:0]
	SDO	Undefined or Read Value Frame depending on previous command		
Read Command Frame	SDI	1 (R/W)	A[6:0]	Don't care
	SDO	Undefined or Read Value Frame depending on previous command		
Read Value Frame	SDI	New Write or Read Command Frame		
	SDO	1 (R/W)	A[6:0]	Data Out[15:0]

The serial clock can be continuous or gated as long as there are exactly 24 falling clock edges within the frame. A write command issued in frames whose width is not 24 bits is incorrect and ignored by the AMC7891. A read command frame not equal to 24 bits may result in abnormal data on SDO and must be ignored by the host processor. In order for another serial transfer to occur, $\overline{CS}$ must be brought low again to start a new cycle. [Figure 24](#) and [Figure 25](#) show multiple write and read operations.

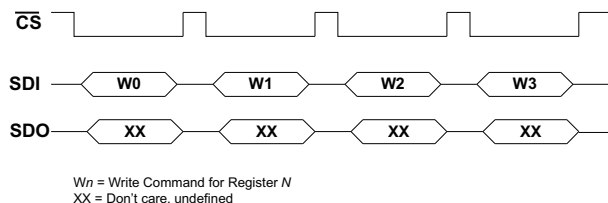


Figure 24. Serial Interface Write Operation

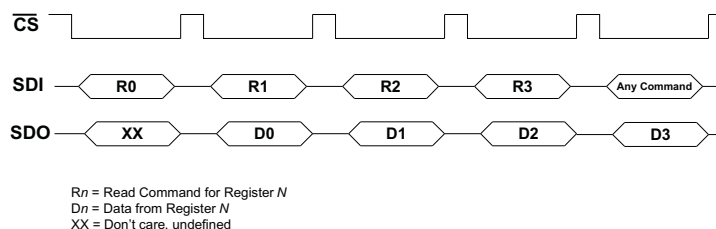


Figure 25. Serial Interface Read Operation

REGISTER MAP

The AMC7891 has 16-bit registers containing device configuration and conversion results. A 7-bit register address indicates the proper register.

Table 2. Register Map

MSB																		LSB			
NAME	ADDR	DEFAULT	BIT 15	BIT 14	BIT 13	BIT 12	BIT 11	BIT 10	BIT 9	BIT 8	BIT 7	BIT 6	BIT 5	BIT 4	BIT 3	BIT 2	BIT 1	BIT 0			
TEMP_data	0x00	0x0000	0	0	0	0	tempdata(11:0)														
TEMP_config	0x0A	0x0008	0	0	0	0	0	0	0	0	0	0	0	0	temp_en	0	0	0			
TEMP_rate	0x0B	0x0007	0	0	0	0	0	0	0	0	0	0	0	0	0	temp_rate(2:0)					
ADC0_data	0x23	0x0000	0	0	0	0	0	0	adc0_data(9:0)												
ADC1_data	0x24	0x0000	0	0	0	0	0	0	adc1_data(9:0)												
ADC2_data	0x25	0x0000	0	0	0	0	0	0	adc2_data(9:0)												
ADC3_data	0x26	0x0000	0	0	0	0	0	0	adc3_data(9:0)												
ADC4_data	0x27	0x0000	0	0	0	0	0	0	adc4_data(9:0)												
ADC5_data	0x28	0x0000	0	0	0	0	0	0	adc5_data(9:0)												
ADC6_data	0x29	0x0000	0	0	0	0	0	0	adc6_data(9:0)												
ADC7_data	0x2A	0x0000	0	0	0	0	0	0	adc7_data(9:0)												
DAC0_data	0x2B	0x0000	0	0	0	0	0	0	dac0_data(9:0)												
DAC1_data	0x2C	0x0000	0	0	0	0	0	0	dac1_data(9:0)												
DAC2_data	0x2D	0x0000	0	0	0	0	0	0	dac2_data(9:0)												
DAC3_data	0x2E	0x0000	0	0	0	0	0	0	dac3_data(9:0)												
DAC0_clear	0x2F	0x0000	0	0	0	0	0	0	dac0_clear(9:0)												
DAC1_clear	0x30	0x0000	0	0	0	0	0	0	dac1_clear(9:0)												
DAC2_clear	0x31	0x0000	0	0	0	0	0	0	dac2_clear(9:0)												
DAC3_clear	0x32	0x0000	0	0	0	0	0	0	dac3_clear(9:0)												
GPIO_config	0x33	0x0000	0	0	0	0	ioc3_io	ioc2_io	ioc1_io	ioc0_io	iob3_io	iob2_io	iob1_io	iob0_io	ioa3_io	ioa2_io	ioa1_io	ioa0_io			
GPIO_out	0x34	0x0000	0	0	0	0	ioc3_out	ioc2_out	ioc1_out	ioc0_out	iob3_out	iob2_out	iob1_out	iob0_out	ioa3_out	ioa2_out	ioa1_out	ioa0_out			
GPIO_in	0x35	NA	0	0	0	0	ioc3_in	ioc2_in	ioc1_in	ioc0_in	iob3_in	iob2_in	iob1_in	iob0_in	ioa3_in	ioa2_in	ioa1_in	ioa0_in			
AMC_config	0x36	0x2000	0	0	adc_mode	adc_trig	dac_load	resvd	adc_rate(1:0)		adc_ready	0	0	0	0	0	0	0			
ADC_enable	0x37	0x0000	0	adc0_en	adc1_en	resvd	adc2_en	adc3_en	resvd	adc4_en	adc5_en	adc6_en	adc7_en	0	0	0	0	0			
ADC_gain	0x38	0xFF00	adc0_gain	adc1_gain	adc2_gain	adc3_gain	adc4_gain	adc5_gain	adc6_gain	adc7_gain	0	0	0	0	0	0	0	0			
DAC_clear	0x39	0x0000	0	0	0	0	0	0	0	0	0	0	0	0	dac3_clear	dac2_clear	dac1_clear	dac0_clear			
DAC_sync	0x3A	0x0000	0	0	0	0	0	0	0	0	0	0	0	0	dac3_sync	dac2_sync	dac1_sync	dac0_sync			
AMC_power	0x3B	0x0000	0	adc_on	ref_on	dac0_on	dac1_on	dac2_on	dac3_on	0	0	0	0	0	0	0	0	0			
AMC_reset	0x3E	0x0000	reset(15:0)																		
AMC_ID	0x40	0x0044	device_id(15:0)																		

REGISTER DESCRIPTIONS

Register name: temp_data – Address: 0x00, Default: 0x0000 (READ ONLY)

Register Name	Address	Bit	Name	Function	Default Value
temp_data	0x00	15:12	Reserved	Reserved for factory use.	All zeros
		11:0	temp_data(11:0)	Stores the temperature sensor reading in twos complement format. 0.125°C/LSB.	0x000

Register name: temp_config – Address: 0x0A, Default: 0x0008 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
temp_config	0x0A	15:4	Reserved	Reserved for factory use.	All zeros
		3	temp_en	When set to '1', the on-chip temperature sensor is enabled.	1
		2:0	Reserved	Reserved for factory use.	All zeros

Register name: temp_rate – Address: 0x0B, Default: 0x0007 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
temp_rate	0x0B	15:3	Reserved	Reserved for factory use.	All zeros
		2:0	temp_rate(2:0)	Sets the temperature sensor ADC conversion time	111
		temp_rate(2:0)		Conversion time	
		000		128x	
		001		64x	
		010		32x	
		011		16x	
		100		8x	
		101		4x	
		110		2x	
111		15 ms			

Register name: ADCn_data – Address: 0x23 to 0x2A, Default: 0x0000 (READ ONLY)⁽¹⁾

Register Name	Address	Bit	Name	Function	Default Value																											
ADCn_data	0x23 to 0x2A	15:10	Reserved	Reserved for factory use.	All zeros																											
		9:0	adc_n_data(9:0)	Stores the 10-bit ADCn conversion results in straight binary format.	All zeros																											
				<table><tr><th>Input Channel</th><th>ADC Register Value</th><th>Register Address</th></tr><tr><td>AIN_0</td><td>adc0_data(9:0)</td><td>0x23</td></tr><tr><td>AIN_1</td><td>adc1_data(9:0)</td><td>0x24</td></tr><tr><td>AIN_2</td><td>adc2_data(9:0)</td><td>0x25</td></tr><tr><td>AIN_3</td><td>adc3_data(9:0)</td><td>0x26</td></tr><tr><td>AIN_4</td><td>adc4_data(9:0)</td><td>0x27</td></tr><tr><td>AIN_5</td><td>adc5_data(9:0)</td><td>0x28</td></tr><tr><td>AIN_6</td><td>adc6_data(9:0)</td><td>0x29</td></tr><tr><td>AIN_7</td><td>adc7_data(9:0)</td><td>0x2A</td></tr></table>		Input Channel	ADC Register Value	Register Address	AIN_0	adc0_data(9:0)	0x23	AIN_1	adc1_data(9:0)	0x24	AIN_2	adc2_data(9:0)	0x25	AIN_3	adc3_data(9:0)	0x26	AIN_4	adc4_data(9:0)	0x27	AIN_5	adc5_data(9:0)	0x28	AIN_6	adc6_data(9:0)	0x29	AIN_7	adc7_data(9:0)	0x2A
				Input Channel		ADC Register Value	Register Address																									
				AIN_0		adc0_data(9:0)	0x23																									
				AIN_1		adc1_data(9:0)	0x24																									
				AIN_2		adc2_data(9:0)	0x25																									
				AIN_3		adc3_data(9:0)	0x26																									
				AIN_4		adc4_data(9:0)	0x27																									
				AIN_5		adc5_data(9:0)	0x28																									
AIN_6	adc6_data(9:0)	0x29																														
AIN_7	adc7_data(9:0)	0x2A																														

(1) All ADCn_data registers are formatted in the manner shown here. n = 0, 1, ..., 7

Register name: DAC_n_data – Address: 0x2B to 0x2E, Default: 0x0000 (READ/WRITE)⁽¹⁾

Register Name	Addresses	Bit	Name	Function	Default Value
DAC _n _data	0x2B to 0x2E	15:10	Reserved	Reserved for factory use.	All zeros
		9:0	dac _n _data(9:0)	Stores the 10-bit data to be loaded to the DAC _n latches in straight binary format.	All zeros
			Output Channel	DAC Register Value	Register Address
			DACOUT_0	dac0_data(9:0)	0x2B
			DACOUT_1	dac1_data(9:0)	0x2C
			DACOUT_2	dac2_data(9:0)	0x2D
			DACOUT_3	dac3_data(9:0)	0x2E

(1) All DAC_n_data registers are formatted in the manner shown here. *n* = 0, 1, ..., 3

Register name: DAC_n_clear – Address: 0x2F to 0x32, Default: 0x0000 (READ/WRITE)⁽¹⁾

Register Name	Address	Bit	Name	Function	Default Value
DACn_clear	0x2F to 0x32	15:10	Reserved	Reserved for factory use.	All zeros
		9:0	dacn_clear(9:0)	Stores the 10-bit data to be loaded to the DACn when cleared. Straight binary format.	All zeros
			Output Channel	DAC Clear Value	Register Address
			DACOUT_0	dac0_clear(9:0)	0x2F
			DACOUT_1	dac1_clear(9:0)	0x30
			DACOUT_2	dac2_clear(9:0)	0x31
			DACOUT_3	dac3_clear(9:0)	0x32

(1) All DAC_n_data registers are formatted in the manner shown here. *n* = 0, 1, ..., 3

Register name: GPIO_config – Address: 0x33, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
GPIO_config	0x33	15:12	Reserved	Reserved for factory use.	All zeros
		11	ioc3_io	When cleared to '0' the corresponding GPIO is configured as an input and set on high-impedance state (default).	0
		10	ioc2_io		0
		9	ioc1_io	When set to '1' the corresponding GPIO is configured as an output.	0
		8	ioc0_io		0
		7	iob3_io		0
		6	iob2_io		0
		5	iob1_io		0
		4	iob0_io		0
		3	ioa3_io		0
		2	ioa2_io		0
		1	ioa1_io		0
		0	ioa0_io		0

Register name: GPIO_out – Address: 0x34, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
GPIO_out	0x34	15:12	Reserved	Reserved for factory use.	All zeros
		11	ioc3_out	If the corresponding GPIO is configured as an output in register <i>GPIO_config</i> , 0x33, the value on this bit sets the digital output.	0
		10	ioc2_out		0
		9	ioc1_out	If the corresponding GPIO is configured as an input in register <i>GPIO_config</i> , 0x33, this bit is a don't care.	0
		8	ioc0_out		0
		7	iob3_out		0
		6	iob2_out		0
		5	iob1_out		0
		4	iob0_out		0
		3	ioa3_out		0
		2	ioa2_out		0
		1	ioa1_out		0
		0	ioa0_out		0

Register name: GPIO_in – Address: 0x35, Default: NA (READ ONLY)

Register Name	Address	Bit	Name	Function	Default Value
GPIO_in	0x35	15:12	Reserved	Reserved for factory use.	All zeros
		11	ioc3_in	If the corresponding GPIO is configured as an output in register <i>GPIO_config</i> , 0x33, the value on this bit corresponds to the digital output.	0
		10	ioc2_in		0
		9	ioc1_in	If the corresponding GPIO is configured as an output in register <i>GPIO_config</i> 0x33, this bit matches the corresponding value in register <i>GPIO_out</i> , 0x34.	0
		8	ioc0_in		0
		7	iob3_in		0
		6	iob2_in		0
		5	iob1_in		0
		4	iob0_in		0
		3	ioa3_in		0
		2	ioa2_in		0
		1	ioa1_in		0
		0	ioa0_in		0

Register name: AMC_config – Address: 0x36, Default: 0x2000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value										
AMC_config	0x36	15:4	Reserved	Reserved for factory use.	All zeros										
		13	adc_mode	When set to '1', the ADC is in Auto-mode conversion. When cleared to '0', the ADC is in Direct-mode conversion.	1										
		12	adc_trig	When set to '1' triggers a new ADC conversion cycle. The bit is cleared to '0' automatically after the ADC conversion cycle starts.	0										
		11	dac_load	When set to '1' data is loaded into the DAC output channels set to synchronous mode in register <i>dac_sync</i> , 0x3A. The AMC7891 updates the DAC output only if the corresponding <i>dacn_data</i> register has been accessed since the last <i>dac_load</i> trigger. Any DAC channels that have not been accessed are not reloaded again.	0										
		10	Reserved	Reserved for factory use.	0										
		9:8	adc_rate(1:0)	Sets the primary ADC conversion rate <table><tr><th>adc_rate(1:0)</th><th>Conversion time (kSPS)</th></tr><tr><td>00</td><td>500</td></tr><tr><td>01</td><td>250</td></tr><tr><td>10</td><td>125</td></tr><tr><td>11</td><td>62.5</td></tr></table>	adc_rate(1:0)	Conversion time (kSPS)	00	500	01	250	10	125	11	62.5	00
		adc_rate(1:0)	Conversion time (kSPS)												
		00	500												
		01	250												
10	125														
11	62.5														
7	adc_ready	ADC data available indicator in Direct-mode conversion. Always cleared to '0' in Auto-mode conversion. A '1' read from this bit indicates the ADC conversion cycle is complete and new data is available. A '0' read from this bit indicates the ADC conversion cycle is in progress or the ADC is in Auto-mode. To clear this bit one of the following events has to occur: 1. Reading the <i>adcn_data</i> registers. 2. Starting a new ADC conversion cycle.	0												
6:0	Reserved	Reserved for factory use.	All zeros												

Register name: ADC_enable – Address: 0x37, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
ADC_enable	0x37	15	Reserved	Reserved for factory use.	All zeros
		14	adc0_en	When set to '1' the corresponding analog input channel AIN_n (n = 0, 1, ..., 7) is accessed during an ADC conversion cycle.	0
		13	adc1_en		0
		11	adc2_en		0
		10	adc3_en		0
		8	adc4_en	When cleared to '0' the corresponding input channel AIN_n (n = 0, 1, ..., 7) is ignored during an ADC conversion cycle.	0
		7	adc5_en		0
		6	adc6_en		0
		5	adc7_en		0
		12,9	Reserved	Reserved for factory use. <i>Must be set to 0 for proper device operation.</i>	All zeros
		4:0	Reserved	Reserved for factory use.	All zeros

Register name: ADC_gain – Address: 0x38, Default: 0xFF00 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
ADC_gain	0x38	15	adc0_gain	When set to '1' the corresponding analog input channel AIN _n ($n = 0, 1, \dots, 7$) input range is $2 \times V_{REF}$.	1
		14	adc1_gain		1
		13	adc2_gain		1
		12	adc3_gain	When cleared to '0' the corresponding input channel AIN _n ($n = 0, 1, \dots, 7$) input range is V_{REF} .	1
		11	adc4_gain		1
		10	adc5_gain		1
		9	adc6_gain		1
		8	adc7_gain		1
		7:0	Reserved	Reserved for factory use.	All zeros

Register name: DAC_clear – Address: 0x39, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
DAC_clear	0x39	15:4	Reserved	Reserved for factory use.	All zeros
		3	dac3_clear	When set to '1' clears the corresponding DACout _n ($n = 0, 1, \dots, 3$) output to the value specified in register <i>dacn_clear</i> , 0x2F to 0x32.	0
		2	dac2_clear		0
		1	dac1_clear	When cleared to '0' the corresponding DACout _n ($n = 0, 1, \dots, 3$) output returns to normal operation.	0
		0	dac0_clear		0

Register name: DAC_sync – Address: 0x3A, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
DAC_sync	0x3A	15:4	Reserved	Reserved for factory use.	All zeros
		3	dac3_sync	When set to '1' clears the corresponding DACout _n ($n = 0, 1, \dots, 3$) is set to synchronous-mode.	0
		2	dac2_sync		0
		1	dac1_sync	When cleared to '0' the corresponding DACout _n ($n = 0, 1, \dots, 3$) is set to asynchronous-mode.	0
		0	dac0_sync		0

Register name: AMC_power – Address: 0x3B, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
AMC_power	0x3B	15	Reserved	Reserved for factory use.	0
		14	adc_on	When cleared to '0' the primary ADC is in power-down mode. When set to '1' the primary ADC is in active mode.	0
		13	ref_on	When cleared to '0' the internal reference buffer is in power-down mode; the device is in External ADC Reference mode and the REF pin is an input. When set to '1' the internal reference buffer is active; the device is in Internal ADC Reference mode and the REF pin is an output.	0
		12	dac0_on	When cleared to '0' DAC0 is in power-down mode. DACout ₀ is in high-impedance state. When set to '1' DAC0 is in active mode.	0
		11	dac1_on	When cleared to '0' DAC1 is in power-down mode. DACout ₁ is in high-impedance state. When set to '1' DAC1 is in active mode.	0
		10	dac2_on	When cleared to '0' DAC2 is in power-down mode. DACout ₂ is in high-impedance state. When set to '1' DAC2 is in active mode.	0
		9	dac3_on	When cleared to '0' DAC3 is in power-down mode. DACout ₃ is in high-impedance state. When set to '1' DAC3 is in active mode.	0
		8:0	Reserved	Reserved for factory use.	All zeros

Register name: AMC_reset – Address: 0x3E, Default: 0x0000 (READ/WRITE)

Register Name	Address	Bit	Name	Function	Default Value
AMC_reset	0x3E	15:0	reset(15:0)	Writing 0x6600 to this register forces a reset operation. During reset, all SPI communication is blocked. After issuing the reset, there is a wait of at least 30 μ s before communication can be resumed.	All zeros

Register name: AMC_ID – Address: 0x40, Default: 0x0044 (READ ONLY)

Register Name	Address	Bit	Name	Function	Default Value
AMC_ID	0x40	15:0	device_id(15:0)	A hardwired register that contains the AMC7891 ID.	0x0044

ADC OPERATION

The AMC7891 has two analog-to-digital converters (ADCs): a primary ADC and a secondary ADC. The primary ADC consists of an 8-channel multiplexer, an on-chip track-and-hold, and a successive approximation register (SAR) ADC based on a capacitive digital-to-analog converter (DAC). This ADC runs at rates up to 500 kSPS and converts the uncommitted analog channel inputs, AIN0 to AIN7.

The analog input range for the device can be selected as 0 V to V_{REF} or 0 V to $(2 \times V_{REF})$. The AMC7891 has an on-chip buffered 2.5V reference that can be disabled when an external reference is preferred. The secondary ADC is a part of the on-chip temperature sensing function.

PRIMARY ADC OPERATION

The following sections describe the operation of the primary ADC. The temperature sensor ADC always operates in the background.

ANALOG INPUT FULL SCALE RANGE

The values in register *ADC_gain* determine the full-scale range of the analog inputs. The full-scale range for input channel AINn is V_{REF} when bit *adcn_gain* = 0, or $2 \times V_{REF}$ when *adcn_gain* = 1. Each input must not exceed the supply value of $AV_{DD} + 0.2$ V or $AGND - 0.2$ V.

When internal ADC reference is enabled, the buffered internal reference is used as the ADC reference. When external ADC reference is selected, an external reference voltage applied to the REF pin is the ADC reference.

ANALOG INPUTS

The AMC7891 has 8 uncommitted single-ended analog inputs. Figure 26 shows the equivalent input circuit of the AMC7891. The (peak) input current through the analog inputs depends on the sample rate, input voltage, and source impedance. The current into the AMC7891 charges the internal capacitor array during the sample period. After this capacitance has been fully charged, there is no further input current. The source of the analog input voltage must be able to charge the input capacitance to a 10-bit settling level within the acquisition time. When the converter goes into hold mode, the input impedance is greater than 1 G Ω .

In applications where the signal source has high impedance, it is recommended to buffer the analog input before applying it to the ADC. The analog input range can be programmed to be either 0 V to V_{REF} or 0 V to $(2 \times V_{REF})$. With a gain of 2, the input is effectively divided by two before the conversion takes place. Note that the voltage with respect to AGND on the ADC analog input cannot exceed AV_{DD} .

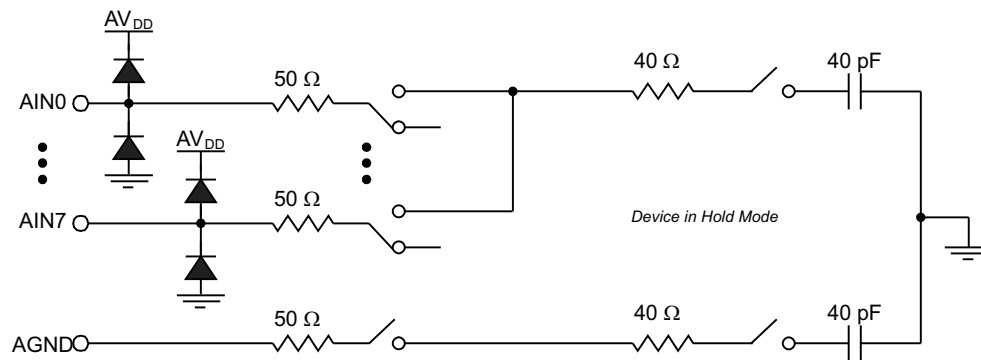


Figure 26. ADC Equivalent Input Circuit

ADC TRIGGER SIGNALS

The ADC can be triggered internally by writing to the *adc_trig* bit in register *AMC_config*. When a new trigger activates, the ADC stops any existing conversion immediately and starts a new cycle. For example, the ADC is programmed to sample input channels 0 to channel 3 repeatedly (auto-mode). During the conversion of channel 1, a trigger is activated. The ADC stops the conversion of channel 1 immediately and starts the conversion of channel 0 again, instead of proceeding to convert channel 2.

CONVERSION MODES

Two types of ADC conversions are available: direct-mode and auto-mode. *adc_mode* bit (*AMC_config* register, bit 13) sets the conversion mode. The default conversion mode is auto-mode (*adc_mode* = '1').

In direct-mode conversion, each analog channel within the specified group in register *ADC_enable* is converted a single time. After the last channel is converted, the ADC goes into an idle state and waits for a new trigger.

Auto-mode conversion, on the other hand, is a continuous operation. In auto-mode, each analog channel within the specified group is converted sequentially and repeatedly.

The flow chart of the ADC conversion sequence in [Figure 27](#) shows the conversion process.

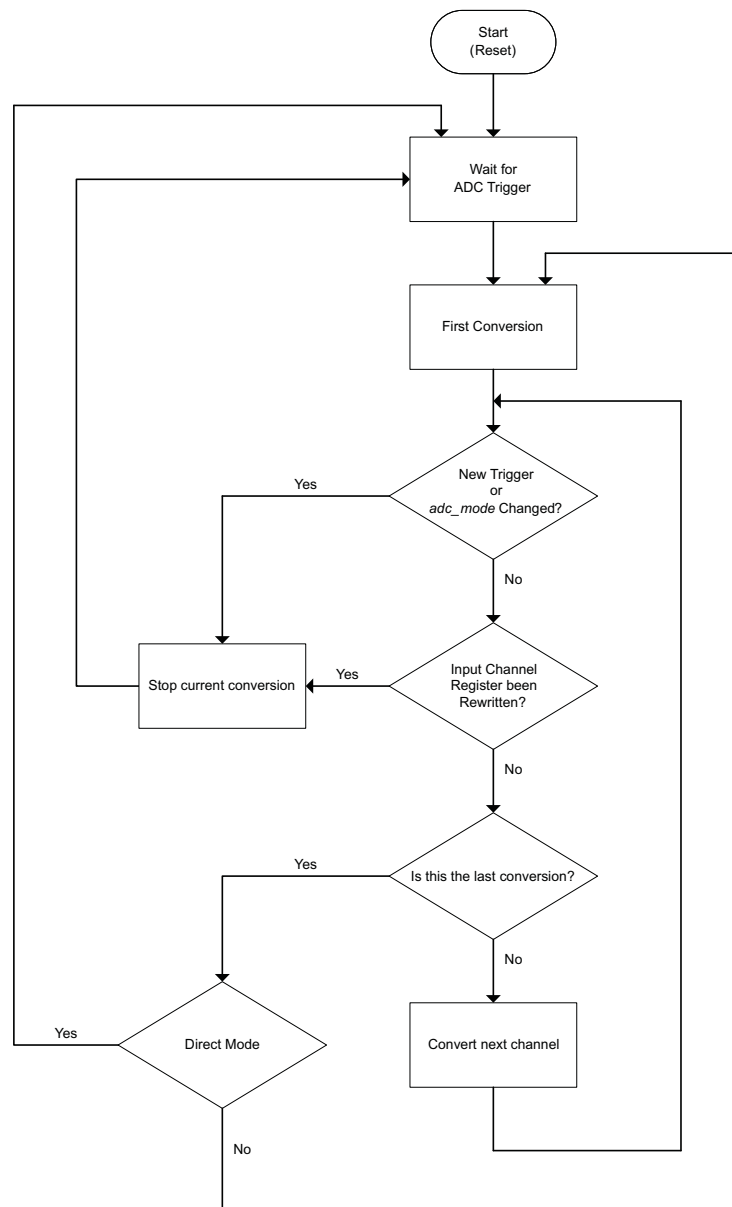


Figure 27. ADC Conversion Sequence

When any of the following events occur, the current conversion cycle stops immediately:

- A new trigger is issued.
- The conversion mode changes.
- Either ADC channel register is rewritten.

When a new trigger activates, the ADC starts a new conversion cycle. The trigger should not be issued at the same time the conversion mode is changed. If a '1' is simultaneously written to the *adc_trig* bit when changing the *adc_mode* bit from '0' to '1', the current conversion stops and immediately returns to the *wait for ADC trigger* state.

To avoid noise caused by the bus clock, it is recommended that no bus clock activity occurs for at least the conversion process time immediately after the ADC conversion starts.

DOUBLE-BUFFERED ADC DATA REGISTER

The host can access all eight, double-buffered *ADCn_data* registers, as shown in Figure 28. The conversion result from the analog input with channel address *n*, (where *n* = 0 to 7) is stored in *adc_n_data[9:0]* in straight binary format. When the conversion of an individual channel is completed, the data is immediately transferred into the corresponding *adc_n_tmpry* temporary register, the first stage of the data buffer. When the conversion of the last channel completes, all data in the *adc_n_tmpry* registers is simultaneously transferred to the corresponding *adc_n_data[9:0]* value, the second stage of the data buffer.

In the case when a data transfer is in progress between any *ADCn_data* register and the AMC7891 shift register, all *ADCn_data* registers are not updated until the data transfer is complete.

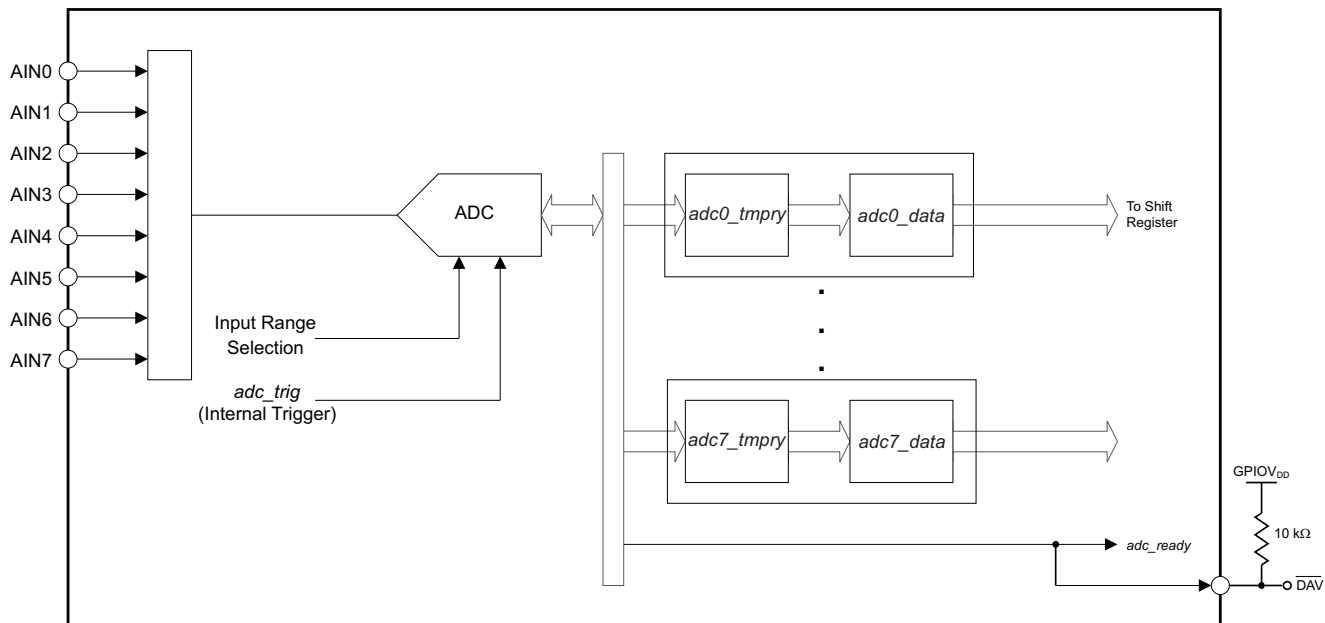


Figure 28. ADC Structure

PROGRAMMABLE CONVERSION RATE

The maximum ADC conversion rate is 500 kSPS for a single channel in auto mode, as shown in Table 3. The conversion rate is programmable through *adc_rate[1:0]* (*AMC_config* register, [9:8] bits). When more than one channel is selected, the conversion rate is divided by the number of channels selected in register *ADC_enable*.

In auto mode, the *adc_rate[1:0]* value determines the actual conversion rate. In direct mode, *adc_rate[1:0]* limits the maximum possible conversion rate. The actual conversion rate in direct mode is determined by the rate of the conversion trigger. Note that when a trigger is issued, there may be a delay of up to 4 μ s to internally synchronize and initiate the start of the sequential channel conversion process. In both direct- and auto- modes, when *adc_rate[1:0]* is set to a value other than the maximum rate ('00'), nap mode is activated between conversions. By activating nap mode, the AV_{DD} supply current is reduced.

Table 3. ADC Conversion Rate

<i>adc_rate[1:0]</i>	t_{ACQ} (μ s)	t_{CONV} (μ s)	NAP ENABLED	THROUGHPUT (Single-Channel Auto Mode)
00	0.375	1.625	No	500 kSPS (default)
01	2.375	1.625	Yes	250 kSPS
10	6.375	1.625	Yes	125 kSPS
11	14.375	1.625	Yes	62.5 kSPS

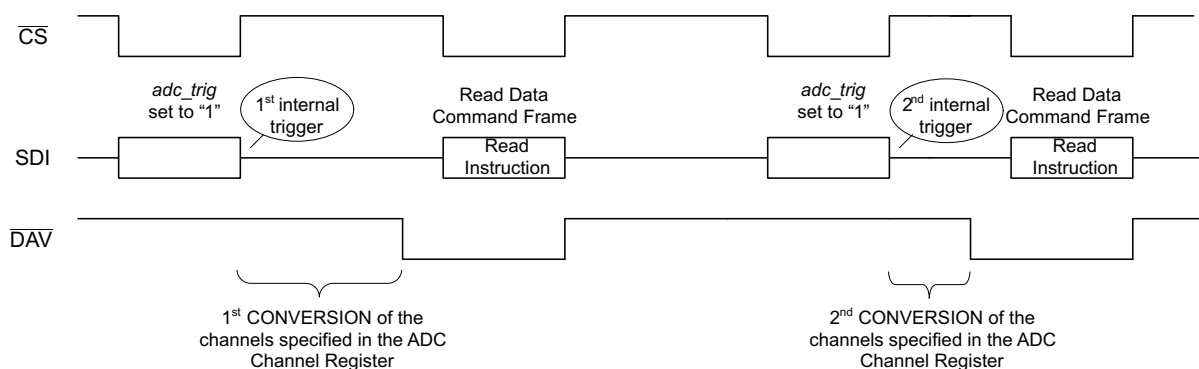
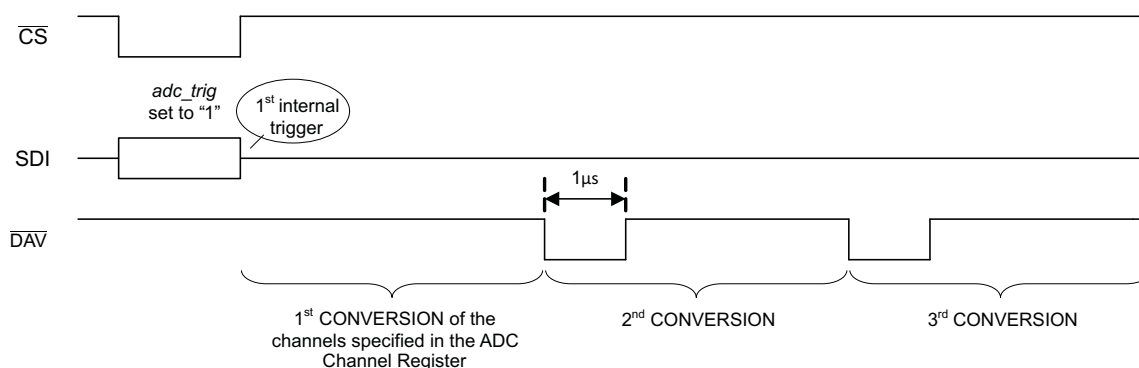
HANDSHAKING WITH THE HOST

The $\overline{DAV}$ pin and *adc_ready* bit (AMC_config register, bit 7) provide handshaking with the host. The $\overline{DAV}$ pin is an open-drain, active low output. If used, an external 10 k Ω pull-up resistor to GPIOV_{DD} is required. If unused, the pin can be connected to DGND. Pin and bit status depend on the conversion mode (direct or auto), as shown in Figure 29.

In direct mode, after the *ADCn_data* registers of all the selected channels in register *adc_enable* are updated, *adc_ready* is set immediately to '1' and the $\overline{DAV}$ pin is active (low) to signify that new data is available.

The *adc_ready* bit is reset to '0' and the $\overline{DAV}$ pin goes back to inactive (high) either by reading any of the *ADCn_data* registers or when a new ADC conversion is started by issuing a trigger by *adc_trig*. The update takes place immediately after the read command frame indicating the read operation or trigger event.

In auto-mode, after the *adc_n_data[9:0]* values are updated, a pulse of 1 μ s (low) appears on the $\overline{DAV}$ pin to signify that new data is available. However, the *adc_trig* bit is inactive and always set to '0'.

a) Direct Mode**b) Auto Mode****Figure 29. ADC Handshaking**

TEMPERATURE SENSOR OPERATION (SECONDARY ADC)

The AMC7891 contains an on-chip temperature sensor used to measure the device temperature. The temperature sensor is continuously monitoring, and new readings are automatically available every cycle. The analog temperature reading is converted by a secondary ADC that runs in the background at a lower speed than the primary ADC.

The temperature measurement relies on the characteristics of a semiconductor junction operating at a fixed current level. The forward voltage of the diode (V_{BE}) depends on the current passing through it and the ambient temperature. The change in V_{BE} when the diode operates at two different currents (a low current of I_{LOW} and a high current of I_{HIGH}), is shown in Equation 1:

$$V_{BE_HIGH} - V_{BE_LOW} = \eta kT/q \times \ln(I_{HIGH}/I_{LOW}) \quad (1)$$

Where:

k is Boltzmann's constant.

q is the charge of the carrier.

T is the absolute temperature in Kelvins (K).

η is the ideality of the transistor as sensor.

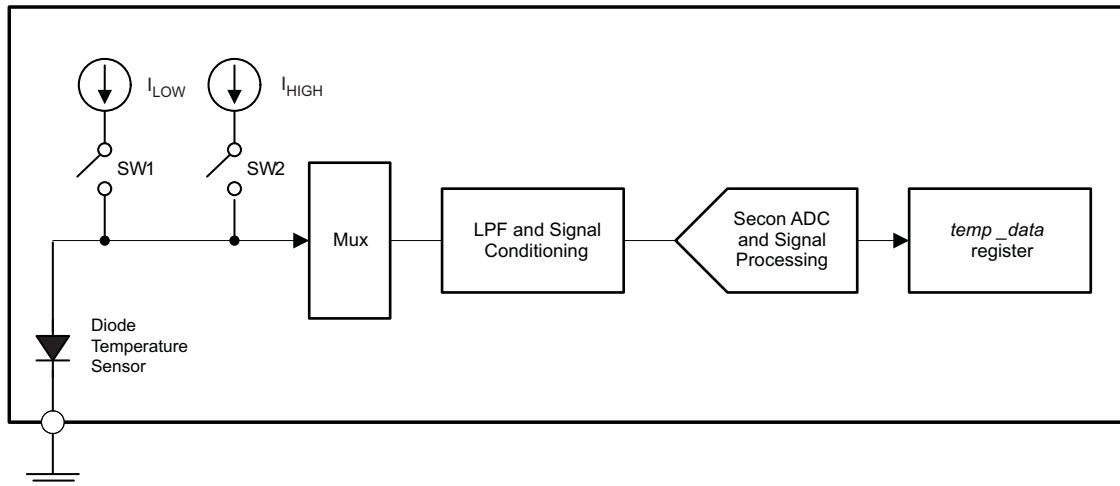


Figure 30. Integrated Temperature Sensor

The temperature sensor can be disabled by clearing to '0' the *temp_en* bit (*TEMP_config* register, bit 3). When disabled, the sensor is not converted. The AMC7891 continuously monitors the temperature sensor in the background, leaving the user free to perform conversions on the primary ADC. When one monitor cycle finishes, a signal passes to the control logic to automatically initiate a new conversion.

The analog sensing signal is preprocessed by a low-pass filter and signal conditioning circuitry, and then digitized by the secondary ADC. The resulting digital signal is further processed by the digital filter and processing unit. The final result is stored as a 12-bit value in the *TEMP_data* register as *tempdata[11:0]*. The format of the final result is in twos complement, as shown in Table 4. Note that the device measures the temperature from -40°C to 150°C .

If a data transfer is in progress between the *TEMP_data* register and the AMC Shift Register, the *TEMP_data* register is frozen until the data transfer is complete.

Table 4. Temperature Data Format

TEMPERATURE (°C)	DIGITAL CODE
+255.875	011111111111
+150	010010110000
+100	001100100000
+50	000110010000
+25	000011001000
+1	000000001000
0	000000000000
-1	111111111000
-25	111100111000
-50	111001110000
-100	110011100000
-150	101101010000
-256	100000000000

The temperature conversion time is by default 15 ms but it can be increased by setting *temp_rate*[2:0] (*TEMP_rate* register, bits [2:0]) as shown in [Table 5](#).

Table 5. Temperature Conversion Time

<i>adc_rate</i> [2:0]	CONVERSION TIME
000	128x
001	64x
010	32x
011	16x
100	8x
101	4x
110	2x
111	15 ms

REFERENCE OPERATION

The AMC7891 includes a buffered internal reference for the ADC, DACs and temperature sensor. The internal reference is a 2.5 V, bipolar transistor-based, precision bandgap reference.

The internal reference always drives the DACs and the internal temperature sensor directly (unbuffered); however the ADC can be driven either by the internal reference (buffered) or by an external one as determined by the *ref_on* bit (*AMC_power* register, bit 13). If used, the external reference is applied to the dual purpose REF pin. A decoupling capacitor is recommended between the external reference output and AGND for noise filtering.

In internal ADC reference mode, the buffered internal reference is available at the REF pin. A compensating 4.7µF capacitor is recommended between the internal buffered reference output and AGND.

On power-up, the AMC7891 is configured for ADC external reference (*ref_on* bit cleared to '0'). In this case it is important that the external reference source is not input into the REF pin until AV_{DD} is stable. If using the internal reference to drive the ADC, the *ref_on* must be set to '1' to enable the internal reference buffer.

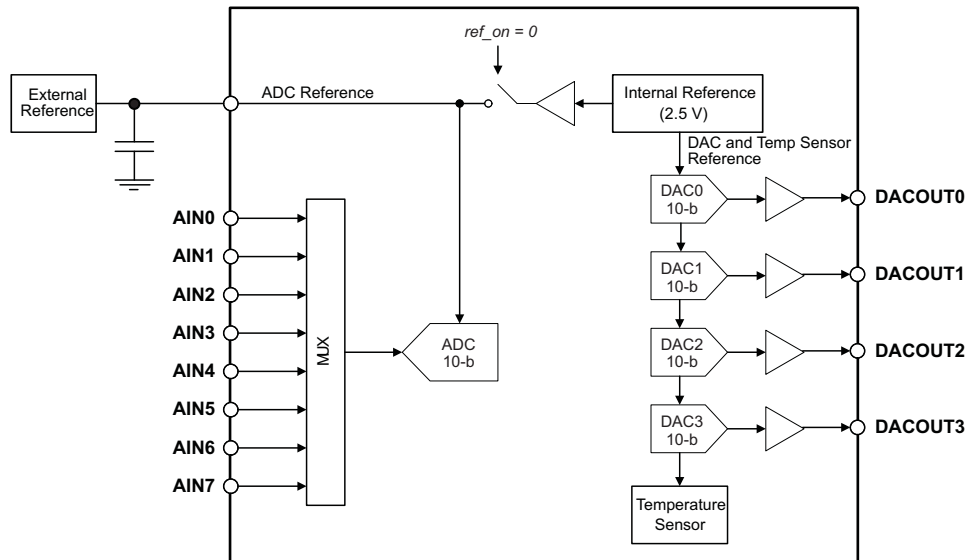


Figure 31. External ADC Reference

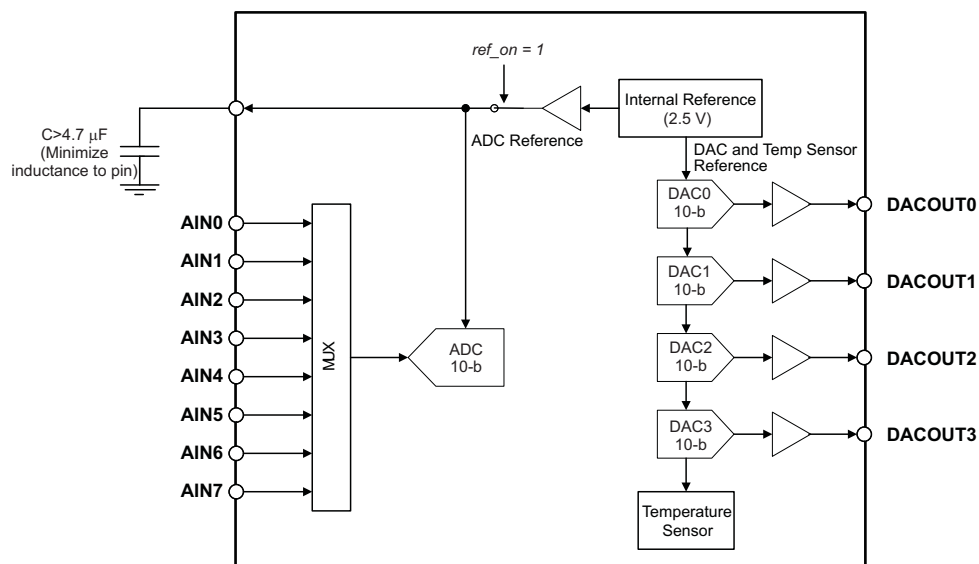


Figure 32. Internal ADC Reference

DAC OPERATION

The AMC7891 contains 4 independent DACs that provide analog control with 10 bits of resolution using an internal reference. Each DAC core consists of a 10-bit string DAC and an output voltage buffer.

The DAC latch stores the code that determines the output voltage from the DAC string. The code is transferred from the *DACn_data* registers to the DACn data latches when the internal DAC load signal is generated.

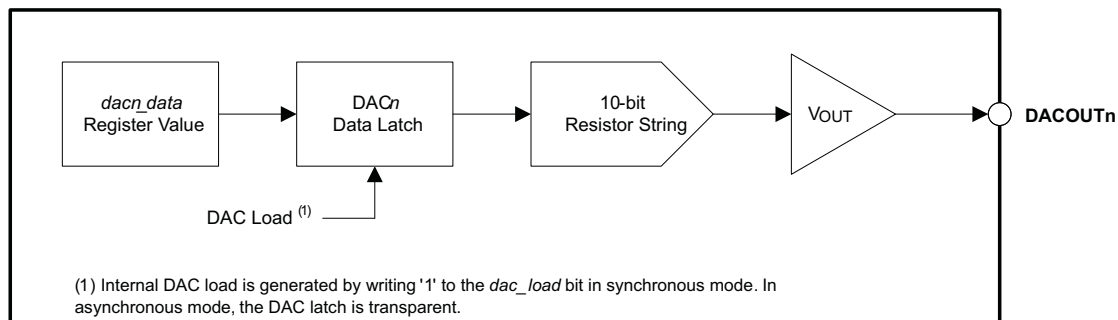


Figure 33. DAC Block Diagram

The resistor string structure is shown in [Figure 34](#). It consists of a string of resistors, each of value R . The code loaded to the DAC Latch determines at which node on the string the voltage is tapped off to be fed into the output amplifier. The voltage is tapped off by closing one of the switches connecting the string to the amplifier. This architecture has inherent monotonicity, voltage output, and low glitch. It is also linear because all the resistors are of equal value.

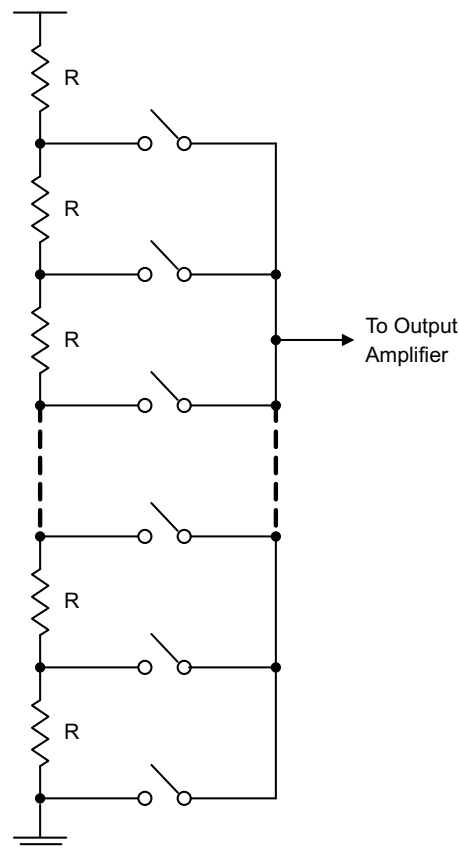


Figure 34. Resistor String

DAC OUTPUT

The full-scale output range of each DAC is set by the product of the internal reference voltage times a fixed gain of 2 in the DAC output buffer ($2 \times V_{REF}$). The full-scale output range of each DAC is limited by the analog power supply. The maximum and minimum outputs from the DAC cannot exceed AV_{DD} or be lower than AGND, respectively.

After power-on or a reset event, the DAC output buffers are in power-down mode. In this mode all *dacn_data* registers and DACn data latches are set to their default values, the output buffers are in a high-impedance state and each DACoutn output pin connects to AGND through an internal 10 kΩ resistor.

DOUBLE-BUFFERED DAC DATA REGISTERS

There are 4 double-buffered DAC data registers. Each DAC has an internal latch preceded by a DAC data register. Data is initially written to the individual *DACn_data* register as the value *dacn_data*[9:0] and then transferred to its corresponding DACn latch. When the DACn latch is updated, the output from pin DACoutn changes to the newly set value. When the host reads from *DACn_data*, the value held in the DACn latch is returned (not the value held in the data register).

The DACs update mode is determined by the *dacn_sync* setting in the *DAC_sync* register. When *dacn_sync* is cleared to '0', the DACn is in asynchronous mode. In asynchronous mode, a write to the *DACn_data* register results in an immediate update of the DACn latch and corresponding DACoutn output.

Synchronous mode is selected by setting *dacn_sync* to '1'. In synchronous mode writing to the *DACn_data* register does not update the DACn latch DACoutn output. Instead, the update occurs only until the *dac_load* bit (*AMC_config* register, bit 11) is set to '1'. By setting the *DAC_sync* register properly, several DACs can be updated at the same time.

Table 6. DAC Output Modes

MODE	<i>dacn_sync</i>	WRITING TO <i>dac_load</i>	OPERATION
Asynchronous	0	Don't care	Update DACn individually. The DACn latch and DACoutn output are immediately updated after writing to <i>DACn_data</i> .
Synchronous	1	1	Simultaneously update all DACs by internal trigger. Writing '1' to <i>dac_load</i> generates an internal load DAC trigger signal that updates the DACn latches and DACoutn outputs with the contents of the corresponding <i>dacn_data</i> [9:0] register values.

The AMC7891 updates the DAC latches only if it has been accessed since the last time *dac_load* was issued, thereby eliminating any unnecessary glitch. Any DAC channels that have not been accessed are not reloaded again. When the DAC latch is updated, the corresponding output changes to the new level immediately.

CLEAR DACS

Each DAC can be cleared using the *DAC_clear* register. When setting the corresponding *dacn_clear* bit to '1', DACn goes to a clear state in which the DACoutn is immediately updated with the predefined value in the *DACn_clear* register, regardless of the *dacn_sync* status. The data register value *dacn_data*[9:0] does not change.

When the DAC goes back to normal operation, the DACoutn output is set back to the DACn latch value regardless of the *dac_sync* status.

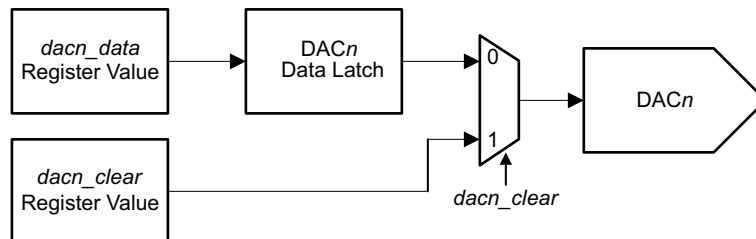


Figure 35. Clear DAC Operation

GENERAL PURPOSE INPUT/OUTPUT PINS

The AMC7891 has twelve GPIO pins. Each GPIO provides a bidirectional, digital I/O signal. These pins can receive an input or produce an output as configured by the *GPIO_config* register.

To configure the GPIOxx pin as an output, the corresponding *ioxx_io* bit needs to be set to '1'. The GPIOxx is an output driver with a pull to the value of the corresponding *ioxx_out* bit in register *GPIO_out*.

To set the GPIOxx pin as an input, the corresponding *ioxx_io* bit has to be cleared to '0'. In this mode the GPIOxx pin is in high-impedance state and the read value is stored in the corresponding *ioutxx_in* bit in register *GPIO_in*. When set as an input, writes to the *GPIO_out* register do not affect the GPIO values.

After a power-on or reset event, all the GPIO pins are set as inputs and, hence in high-impedance state.

POWER-UP SEQUENCE

After all supplies are established, serial communication with the AMC7891 is valid only after a 200 μ s power-up reset delay. Following this, a software reset should be issued to ensure proper operation of the AMC7891. A software reset is issued by writing the value '0x6600' to *reset[15:0]* in register *AMC_reset*. Communication to the AMC7891 is re-established after a 200 μ s delay from the reset operation (measured from the rising edge of $\overline{CS}$ establishing the end of the reset command frame).

At power-up or after a software-reset command all registers are set to the default values (see [Table 6](#)). The default state of all analog blocks is off as determined by the default value of the *AMC_power* register.

For the device to work properly, AV_{DD} must power up before applying any inputs to the GPIO pins. In addition, if using an external ADC reference AV_{DD} must power up before the external reference voltage is applied to the REF pin.

The following power-up sequence is recommended for the AMC7891.

1. No input should be applied to the GPIO pins. Also, if using an external ADC reference, it should not be applied to the REF pin.
2. Supply all voltages (AV_{DD} , $GPIOV_{DD}$ and $SPIV_{DD}$). If possible, it is recommended to apply IOV_{DD} before AV_{DD} . However, the supplies can be powered up simultaneously or in any order with no detrimental effect to the device.
3. After AV_{DD} has been applied there is a 200 μ s power-up reset delay. No serial communication should be attempted during this time.
4. Issue a software-reset command by writing the value '0x6600' to *reset[15:0]* in register *AMC_reset*.
5. Wait at least 200 μ s from the rising edge of $\overline{CS}$ to complete the software-reset.
6. Program the registers according to the desired mode of operation.

APPLICATION INFORMATION

BASE STATION AMPLIFIER MONITOR AND CONTROL

The AMC7891 is a highly integrated, low-power, complete analog monitoring and control system in a small package; all of these features make the AMC7891's an ideal low-cost, bias control circuit for modern RF transistor modules such as the power amplifiers (PA) and low-noise amplifiers (LNA) found in RF communication systems.

The AMC7891 is used in RF amplifier signal chains to set the transistor's optimal bias condition as well as to monitor for any possible malfunction. The AMC7891 four independent DAC outputs allow control of the transistor's gate bias voltages as well as of any variable-gain amplifiers (VGAs) in the signal chain. The AMC7891 twelve configurable GPIOs enable digital signal control and monitoring. Additionally, the device has 8 uncommitted analog inputs driving a highly precise ADC and an accurate on-chip temperature sensor that allow continuous monitoring of the main factors determining optimal amplifier operation such as temperature, supply voltages as well as drain bias currents through external current shunt monitors. The use of external current shunt monitors gives the system designer the flexibility to choose the optimal number of current measurements for the amplifier topology as well as the accuracy, voltage range and gain setting according to the drain current level to be measured. The Texas Instruments' INA282 family, which includes the INA282, INA283, INA284, INA285 and INA286 devices, are highly-accurate, wide common-mode range current shunt monitors with gains going from 50V/V to 1000V/V.

The circuit in [Figure 36](#) shows a typical multi-stage Doherty PA monitoring and control system using the AMC7891. The AMC7891 DAC outputs are used to set the bias gate voltage of each LDMOS transistor in the PA as well as to set the gain of the VGA driving the PA. The AMC7891 ADC inputs are used to monitor the most important parameters in the PA operation: supply voltages, drain bias currents as well as the TX and RX signal power. The GPIOs give additional system flexibility. In the system example below three GPIOs are used to address an external 8:1 multiplexer used for giving additional inputs to the AMC7891 ADC.

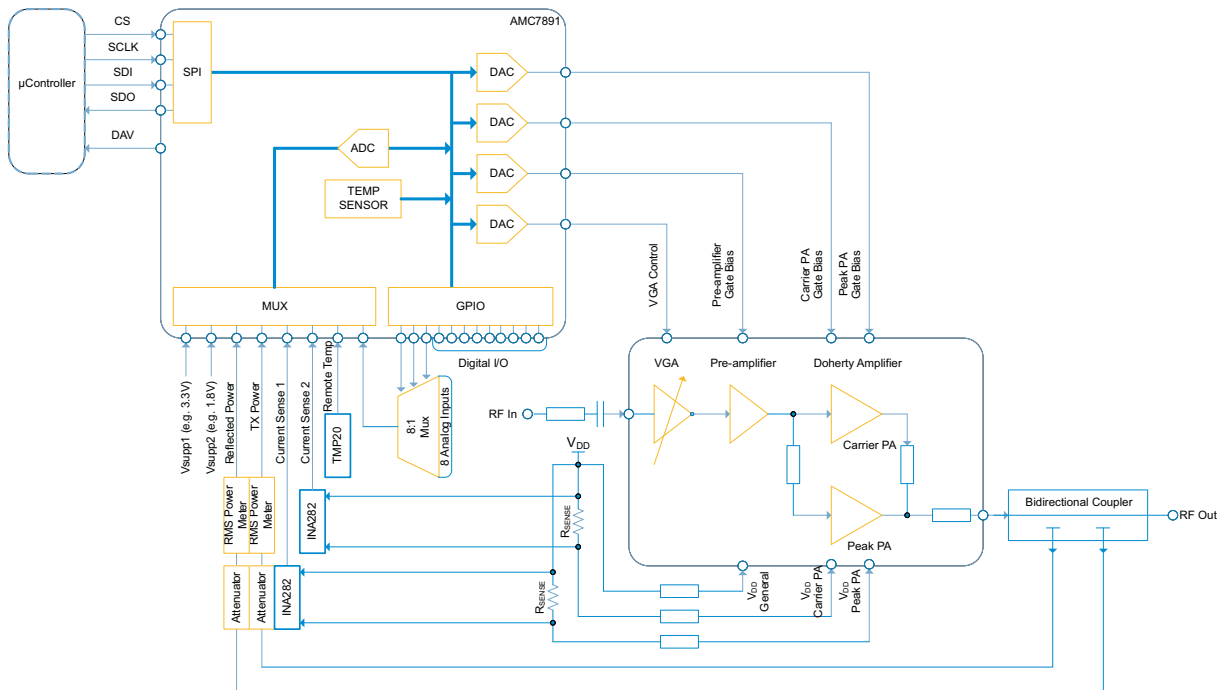


Figure 36. PA Monitor and Control System

REVISION HISTORY

Changes from Original (August 2011) to Revision A	Page
• 从一个3页的产品预览变为一个生产数据表	1
• Added the TYPICAL CHARACTERISTICS: DAC section	10
• Added the TYPICAL CHARACTERISTICS: ADC section	12

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
AMC7891SRHHR	ACTIVE	VQFN	RHH	36	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 105	AMC7891	Samples
AMC7891SRHHT	ACTIVE	VQFN	RHH	36	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 105	AMC7891	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBsolete: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

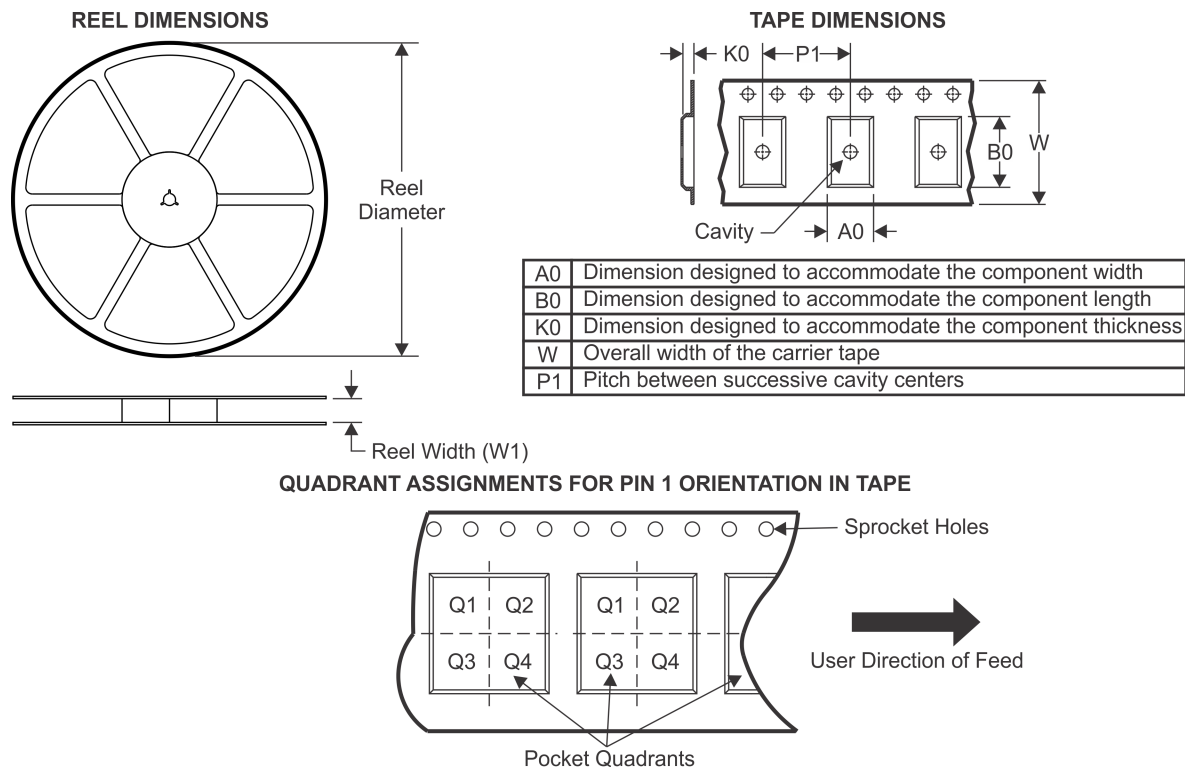
(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "--" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

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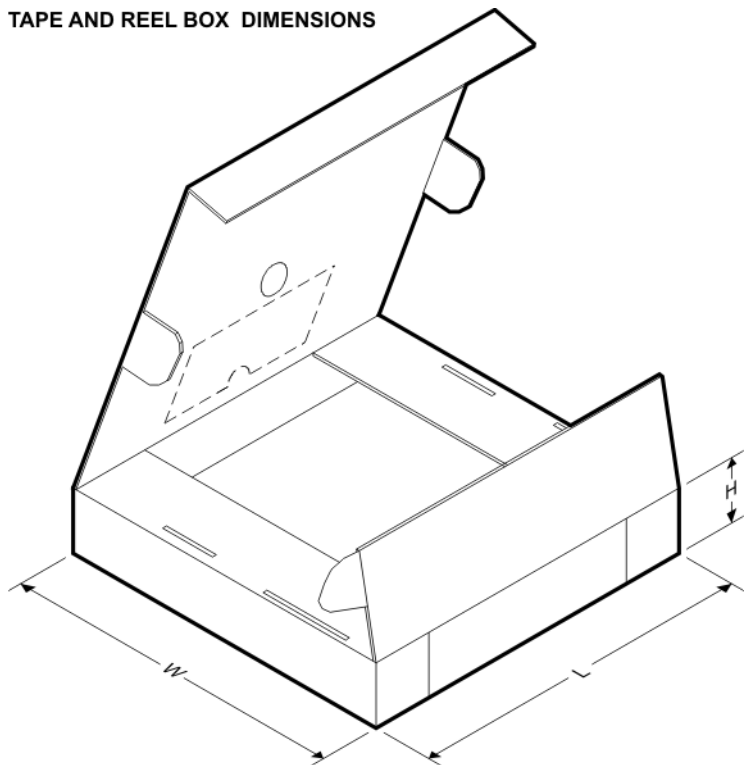
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TAPE AND REEL INFORMATION


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
AMC7891SRHHR	VQFN	RHH	36	2500	330.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2
AMC7891SRHHT	VQFN	RHH	36	250	180.0	16.4	6.3	6.3	1.1	12.0	16.0	Q2

TAPE AND REEL BOX DIMENSIONS

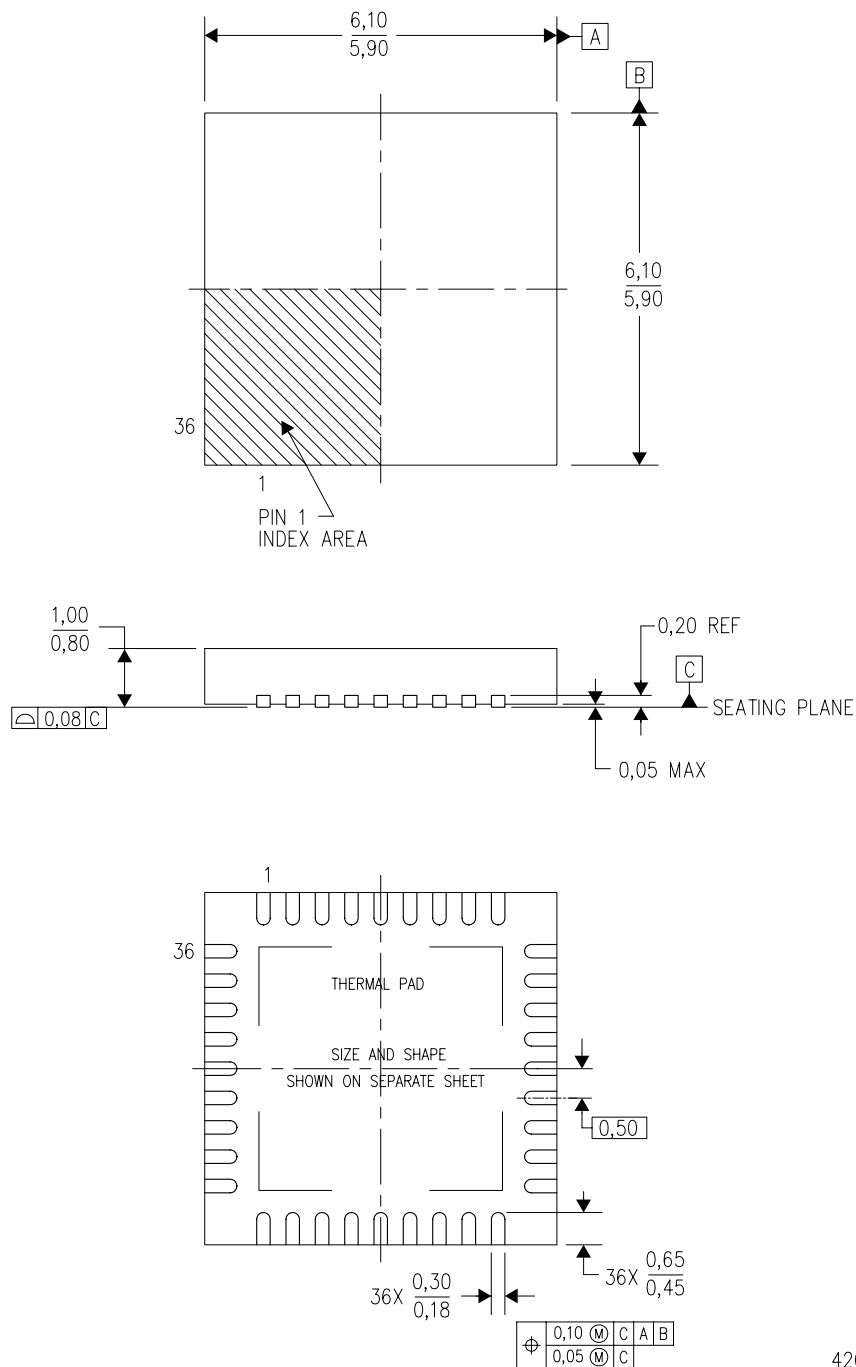


*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
AMC7891SRHHR	VQFN	RHH	36	2500	367.0	367.0	38.0
AMC7891SRHHT	VQFN	RHH	36	250	210.0	185.0	35.0

RHH (S-PVQFN-N36)

PLASTIC QUAD FLATPACK NO-LEAD



4205094/E 06/11

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
 - This drawing is subject to change without notice.
 - QFN (Quad Flatpack No-Lead) Package configuration.
 - The package thermal pad must be soldered to the board for thermal and mechanical performance.
 - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - Falls within JEDEC MO-220.

RHH (S-PVQFN-N36)

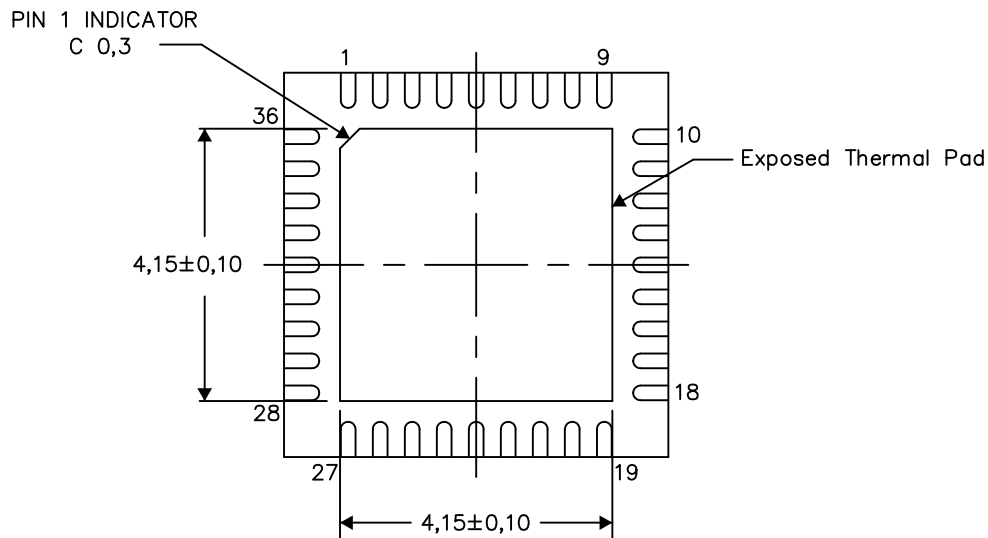
PLASTIC QUAD FLATPACK NO-LEAD

THERMAL INFORMATION

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

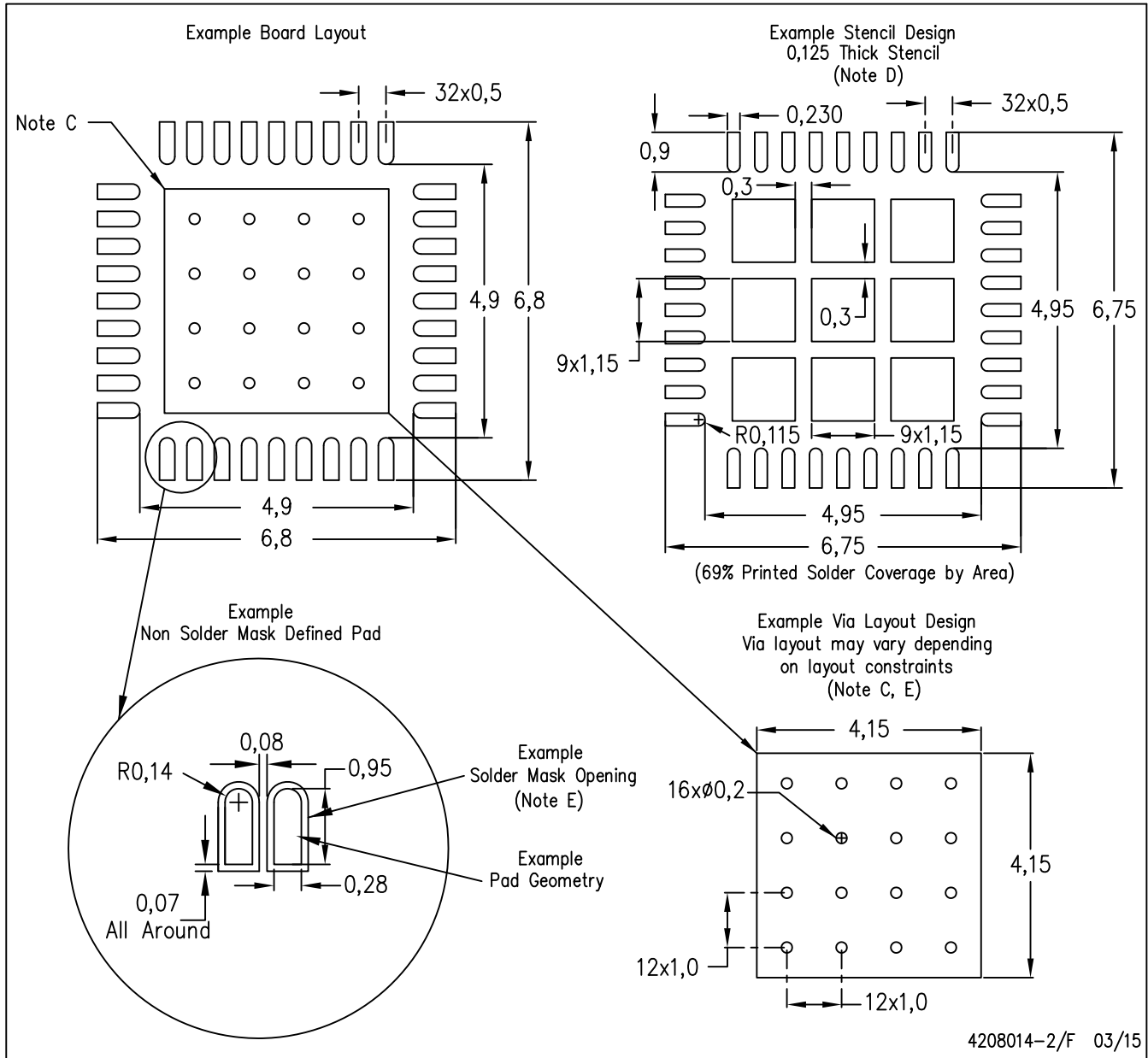
Exposed Thermal Pad Dimensions

4206362-4/M 11/13

NOTE: All linear dimensions are in millimeters

RHH (S-PVQFN-N36)

PLASTIC QUAD FLATPACK NO-LEAD



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack Packages, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>.
 - D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
 - E. Customers should contact their board fabrication site for recommended solder mask tolerances and via tenting recommendations for any larger diameter vias placed in the thermal pad.

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